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(54) **DISPLAY DEVICE AND CONTROLLING METHOD THEREOF**

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(58) **Field of Classification Search** **345/76, 345/82, 204, 212, 690**
See application file for complete search history.

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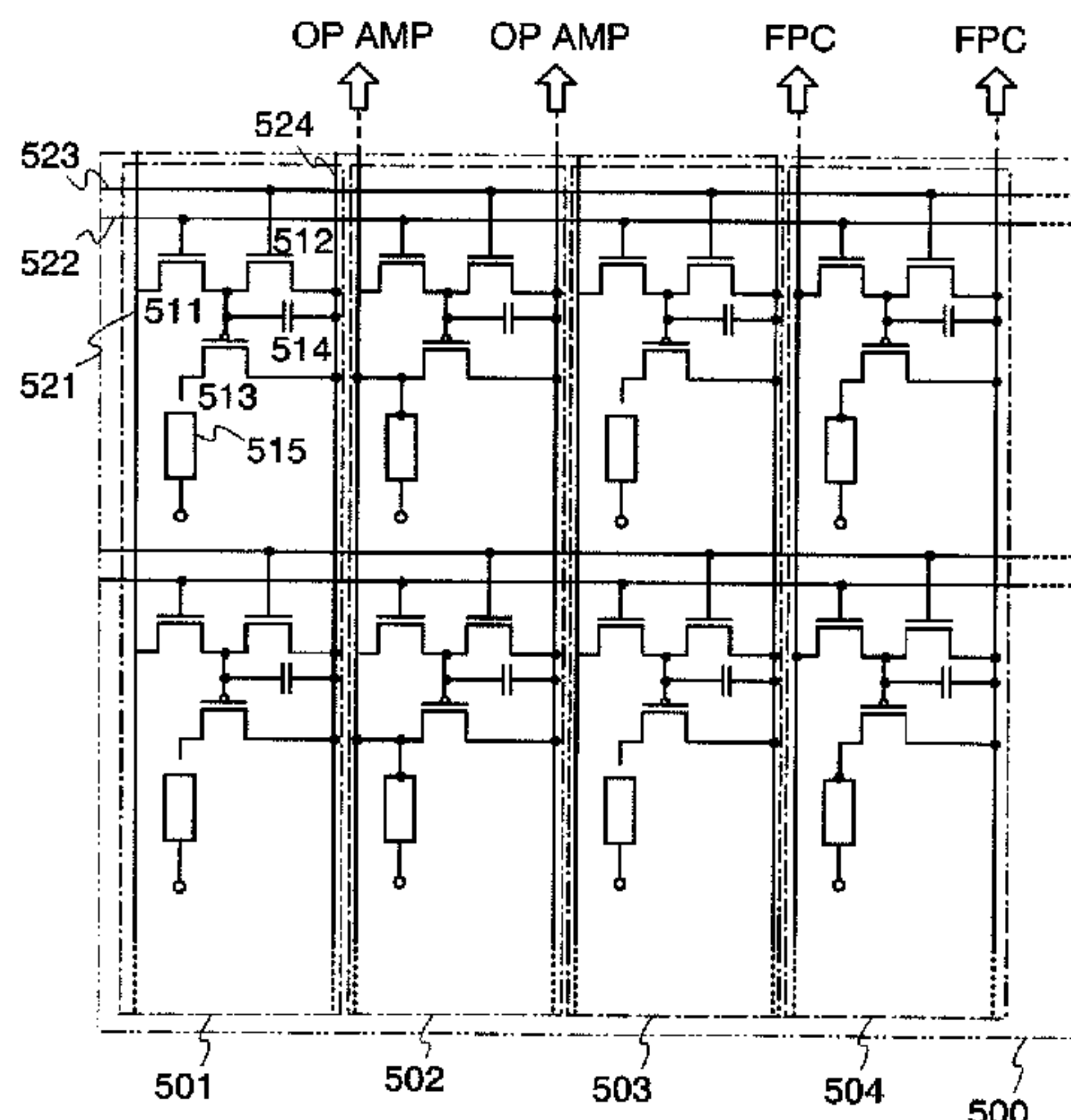
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(57) **ABSTRACT**

A conventional setting voltage was a value with an estimated margin of a characteristic change of a light emitting element. Therefore, a voltage between the source and drain of a driver transistor V_{ds} had to be set high ($V_{ds} \cong V_{gs} - V_{Th} + a$). This caused high heat generation and power consumption because a voltage applied to the light emitting element. The invention is characterized by feedbacking a change in a current value in accordance with the deterioration of a light emitting element and a power source voltage controller which modifies a setting voltage. Namely, according to the invention, the setting voltage is to be set in the vicinity of the boundary (critical part) between a saturation region and a linear region, and a voltage margin for the deterioration is not required particularly for an initial setting voltage.

7 Claims, 13 Drawing Sheets



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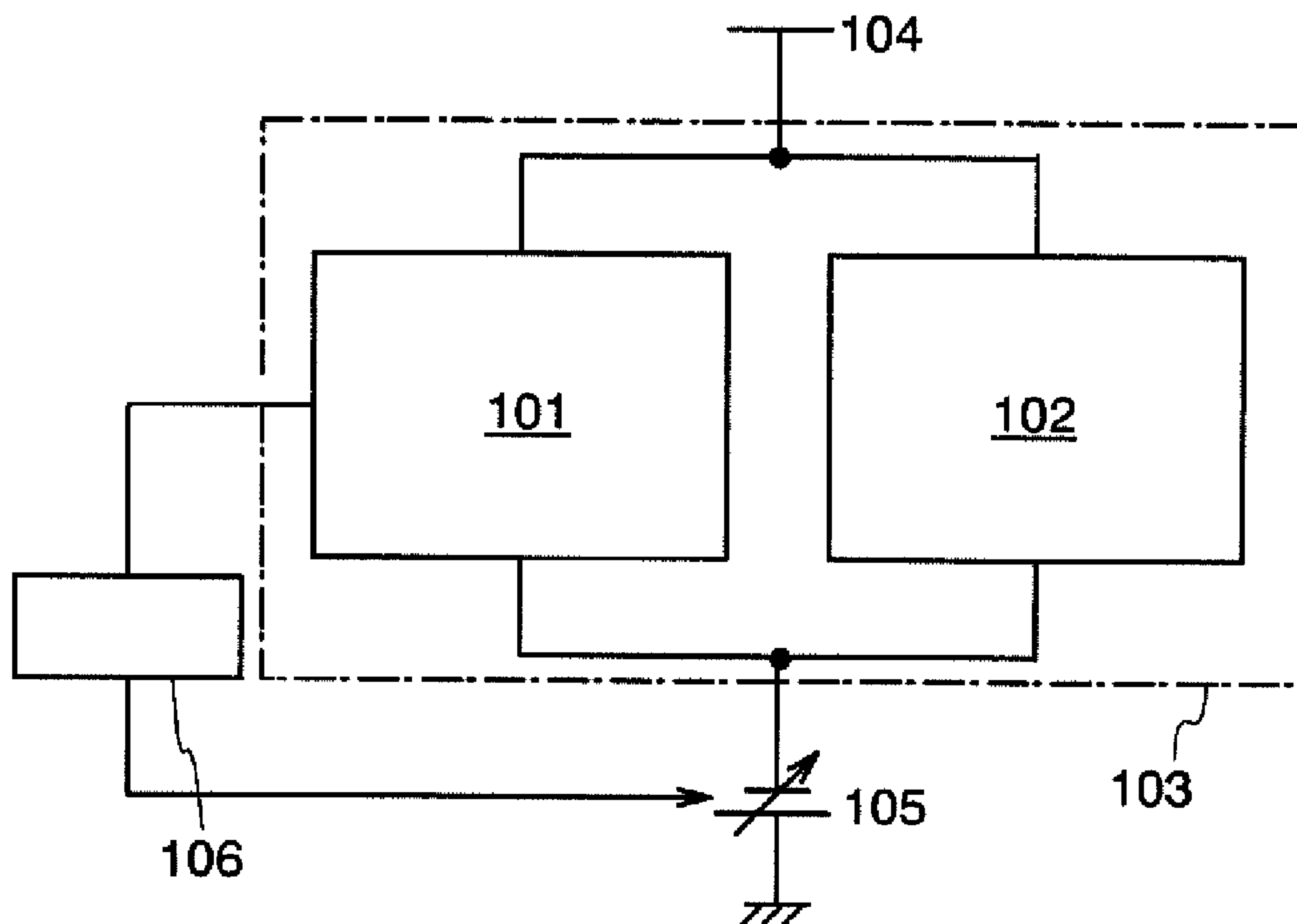


FIG. 1

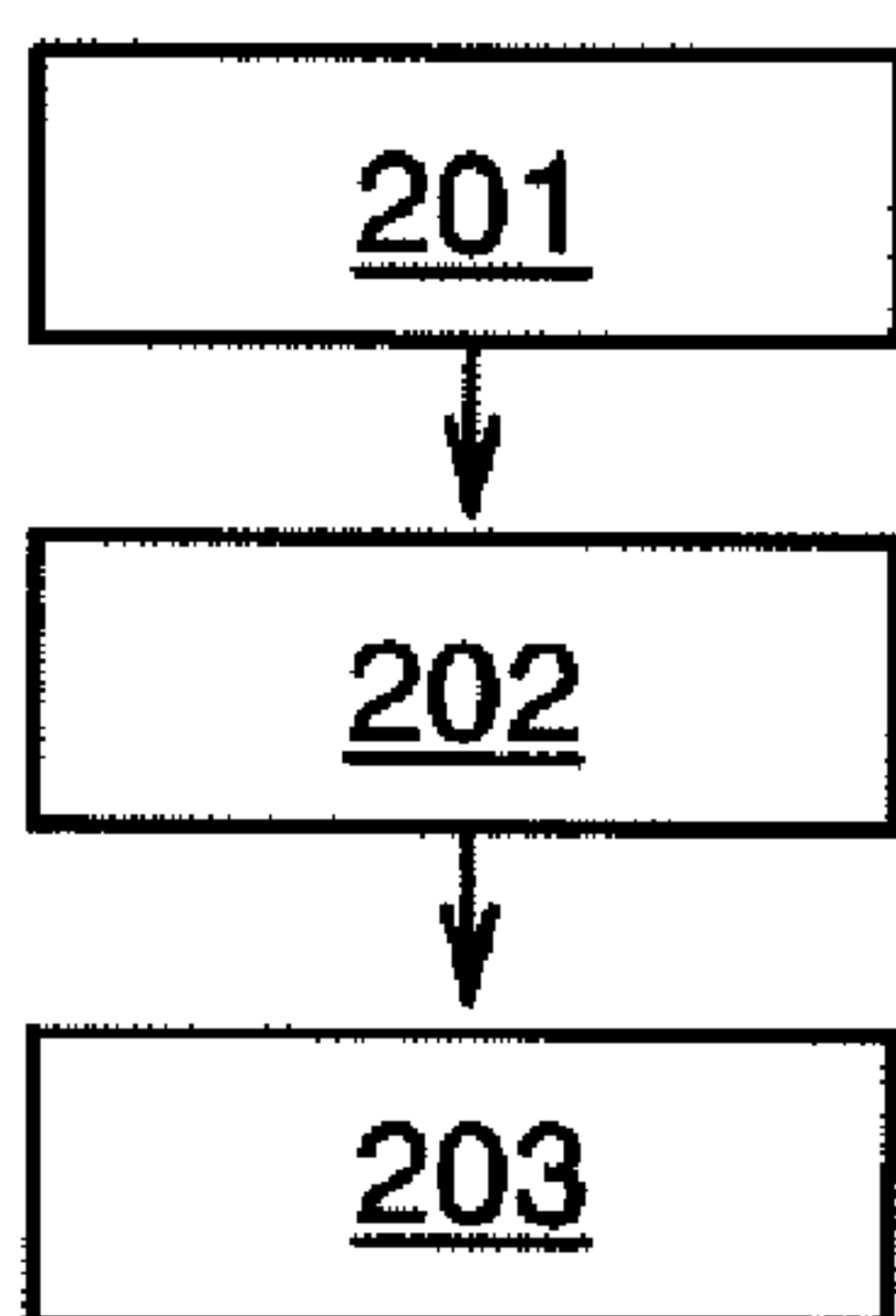


FIG. 2

201:
Setting a driving voltage of a light emitting element in a monitoring element and in a pixel element.

202:
Emitting the light emitting element in the monitoring element and in the pixel element.

203:
Changing the driving voltage of the light emitting element in the monitoring element according to a deterioration of the same, and changing the driving voltage of the light emitting element in the pixel element in synchronization with it.

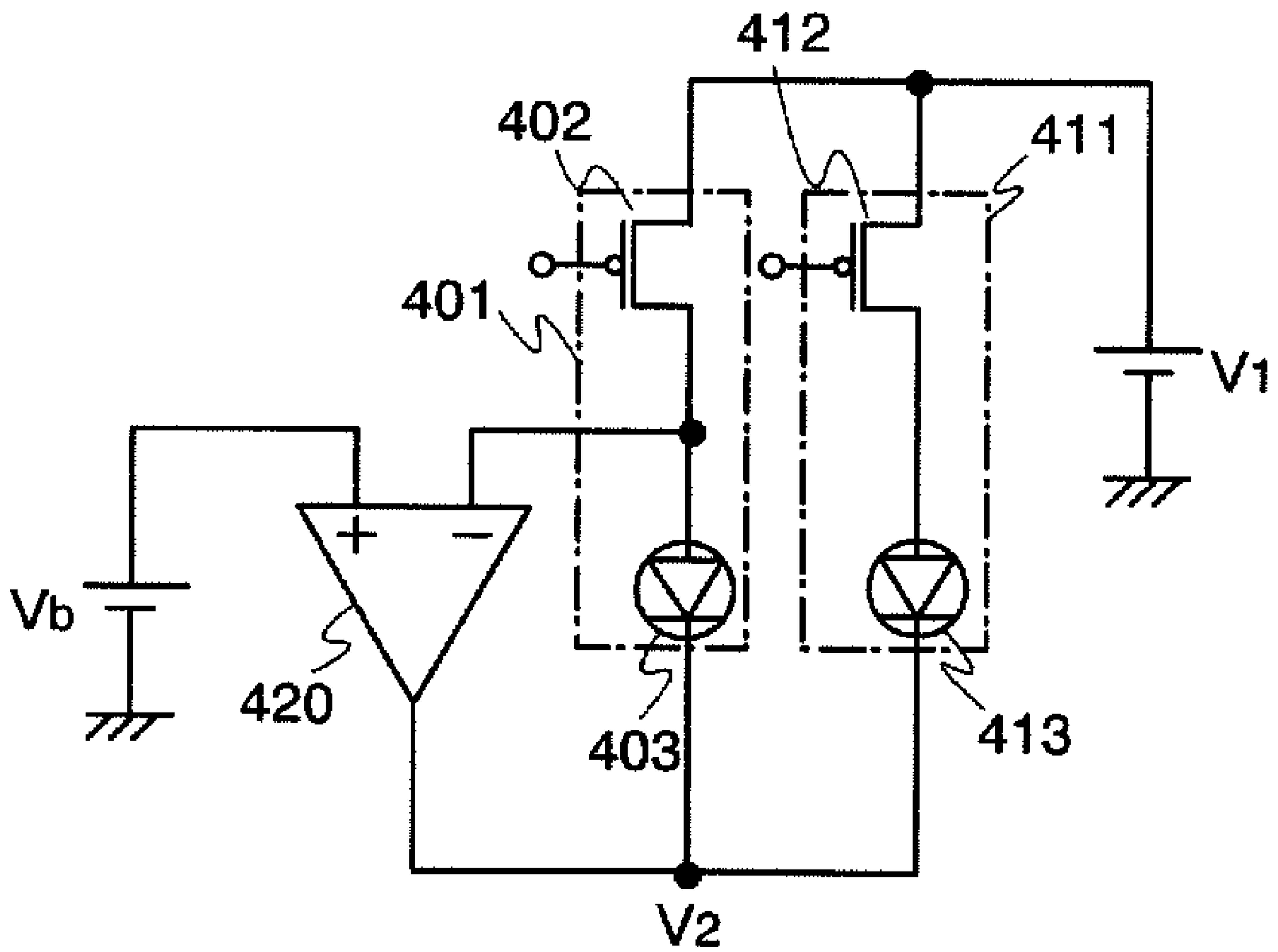


FIG. 4

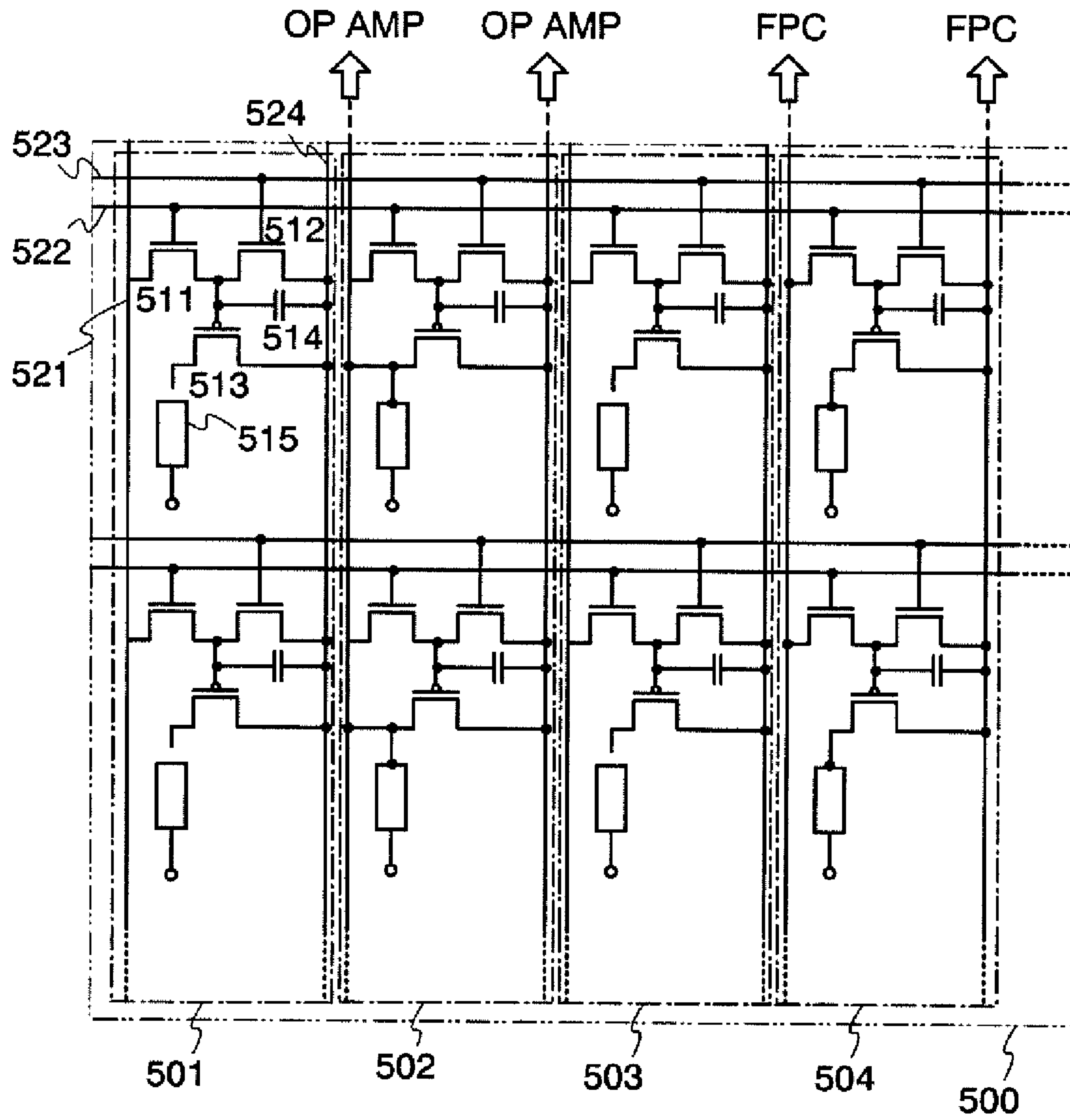


FIG. 5

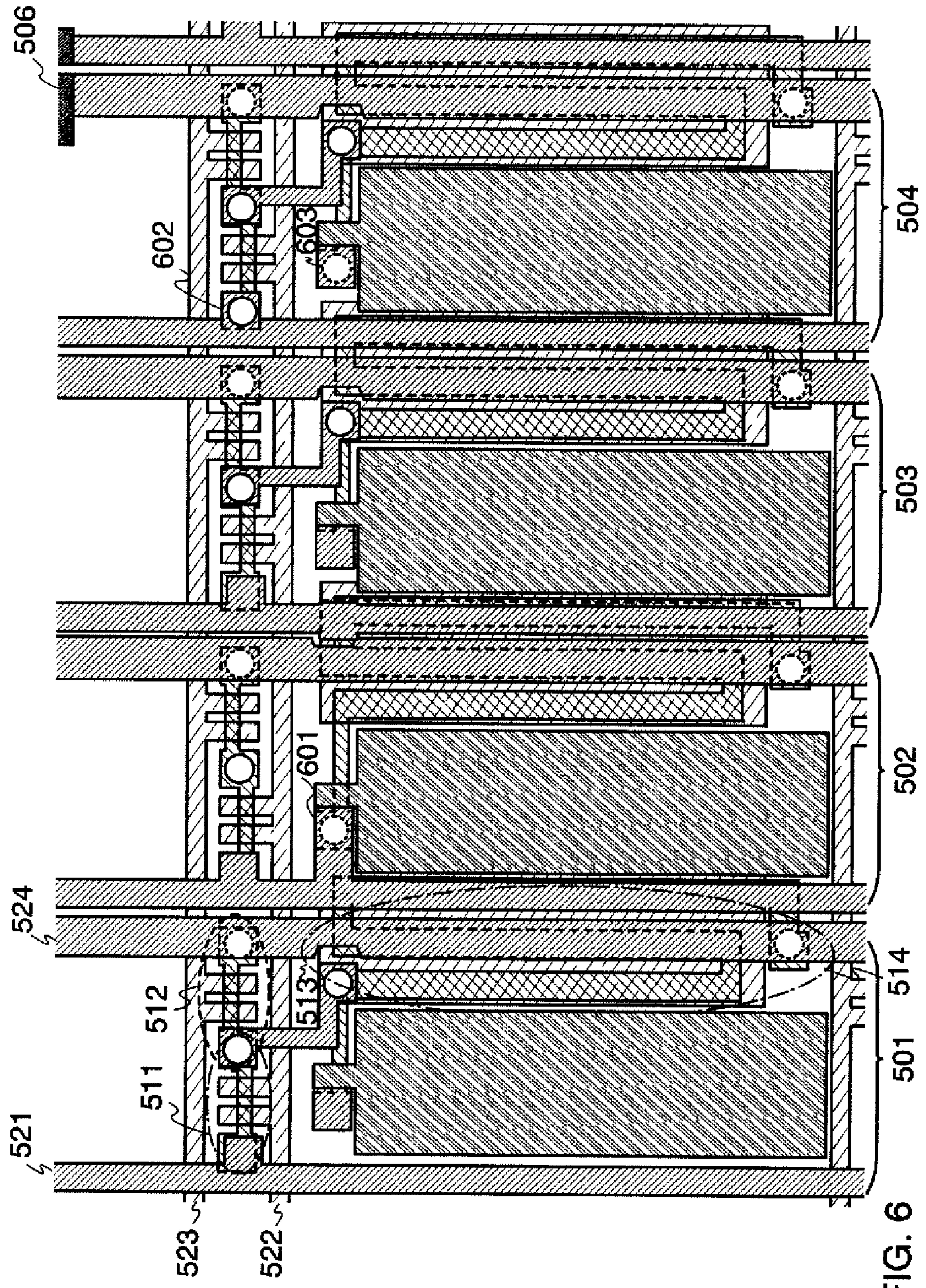


FIG. 6

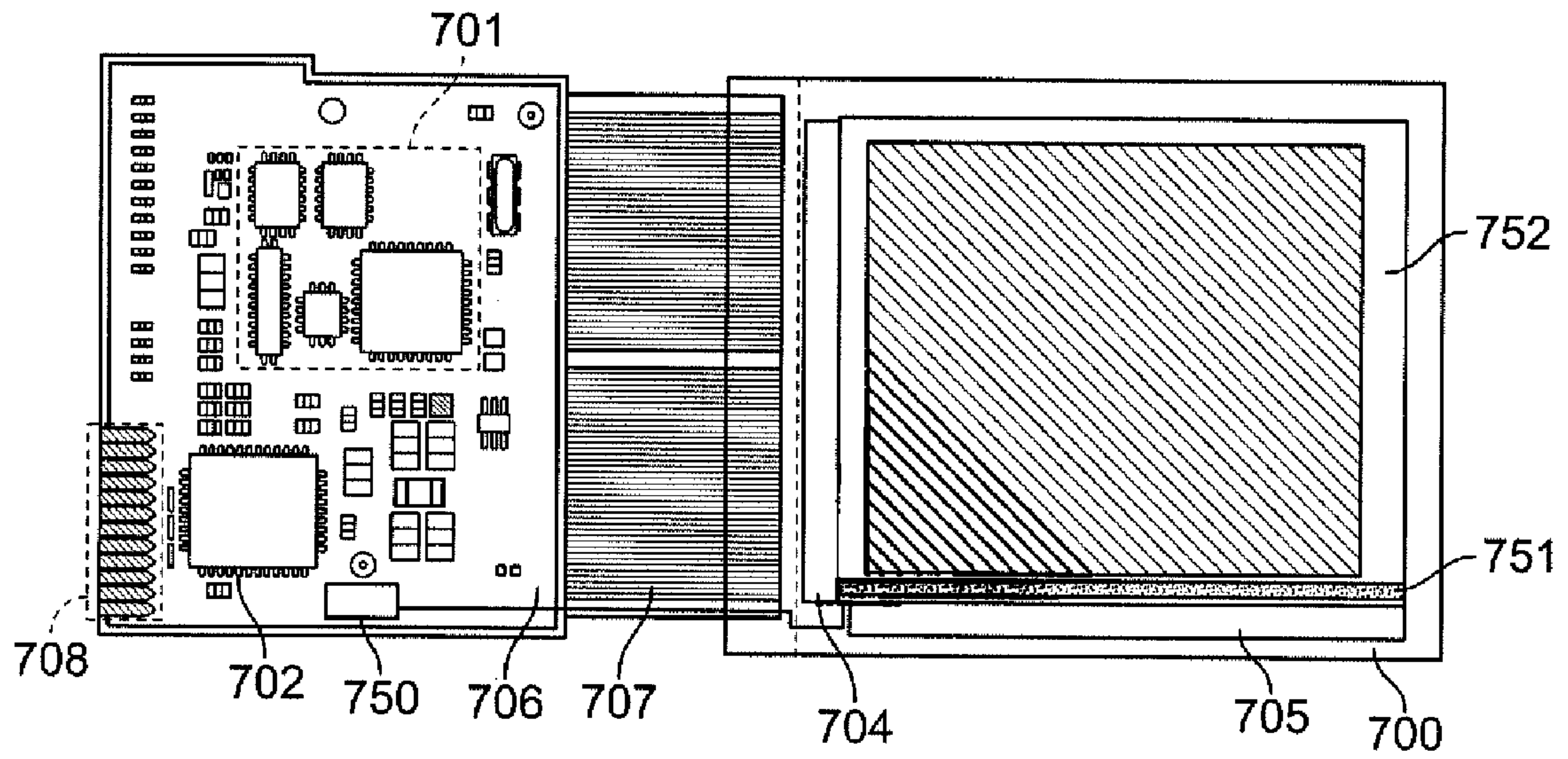


FIG. 7A

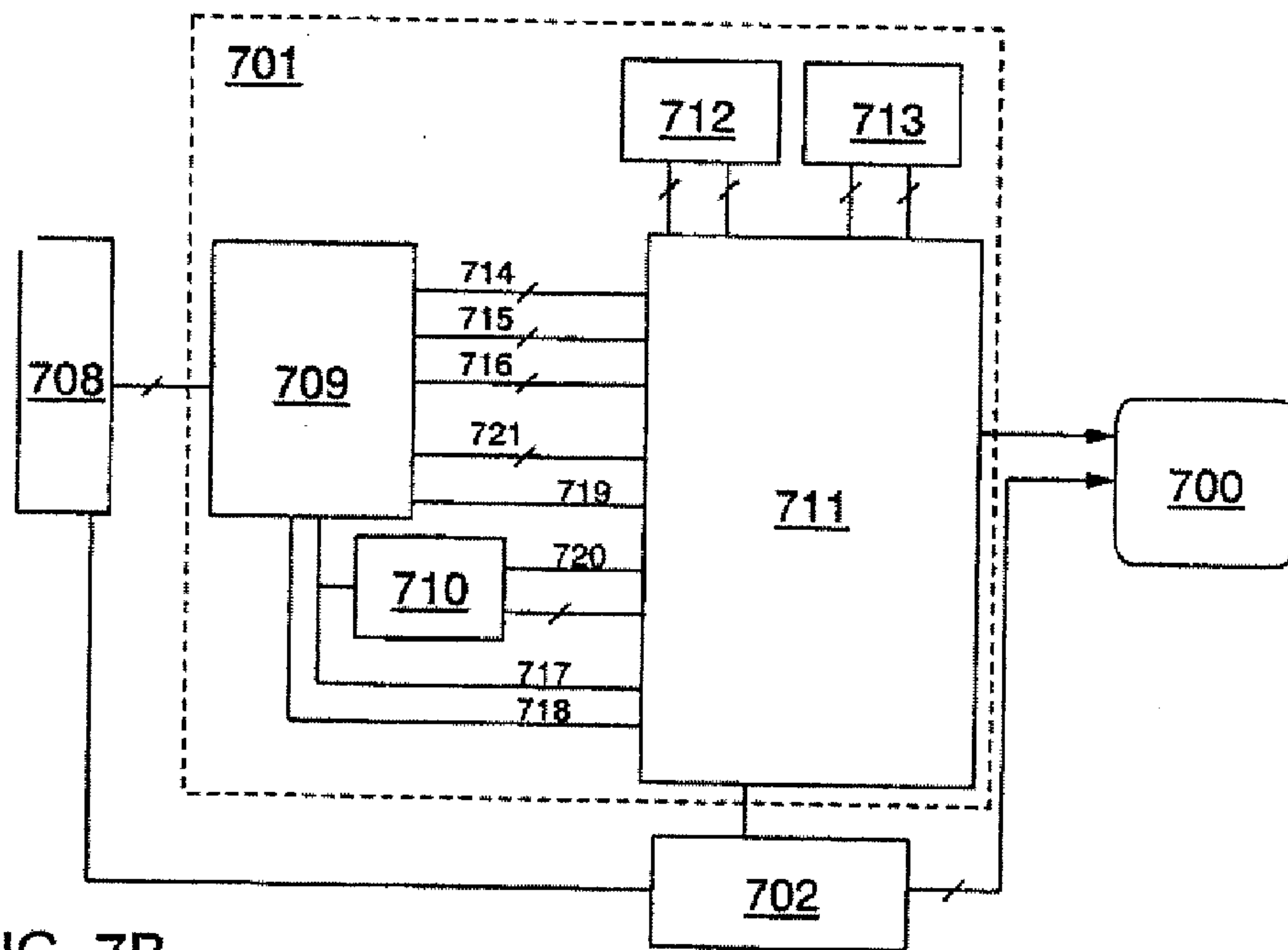


FIG. 7B

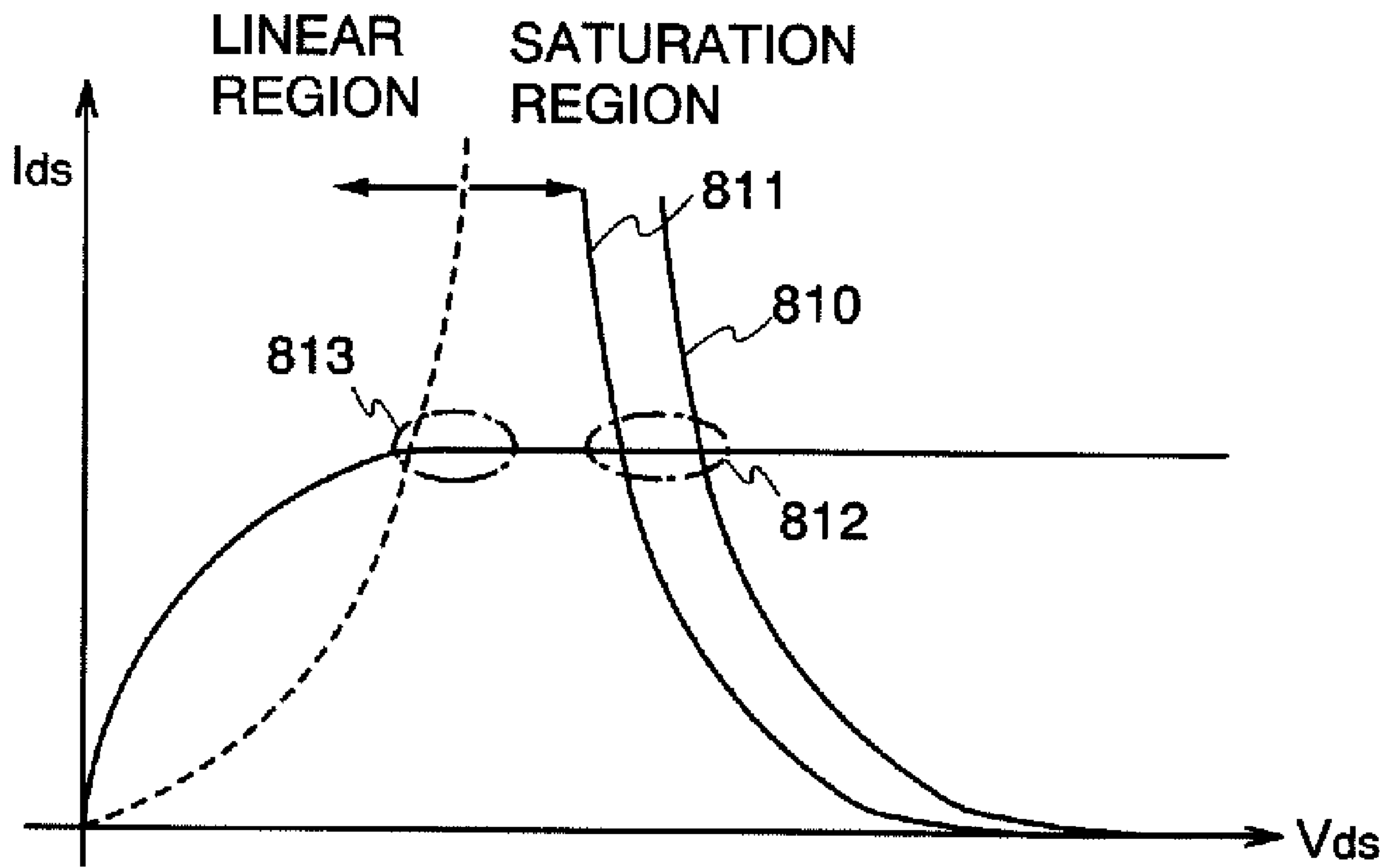


FIG. 8

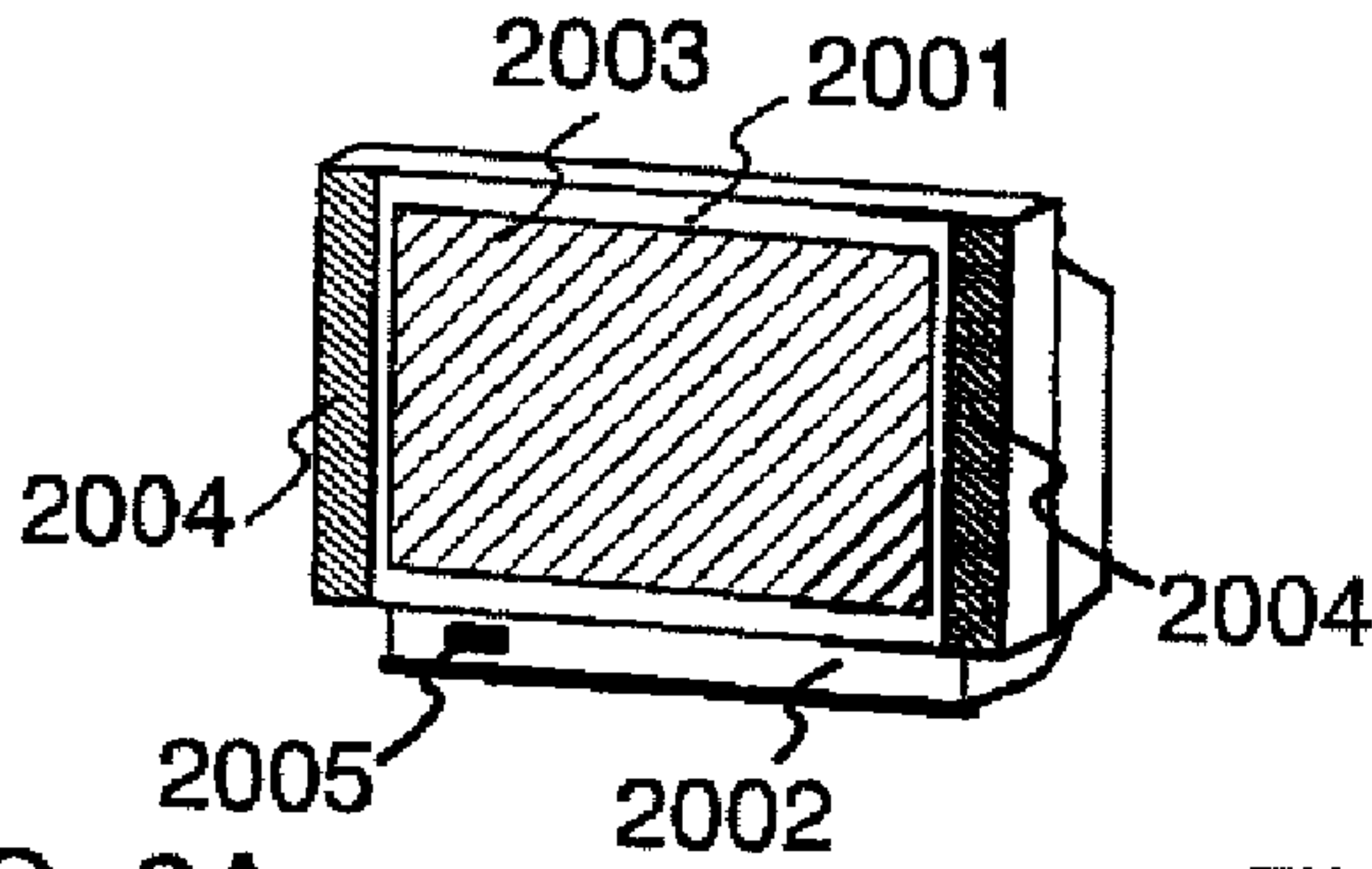


FIG. 9A

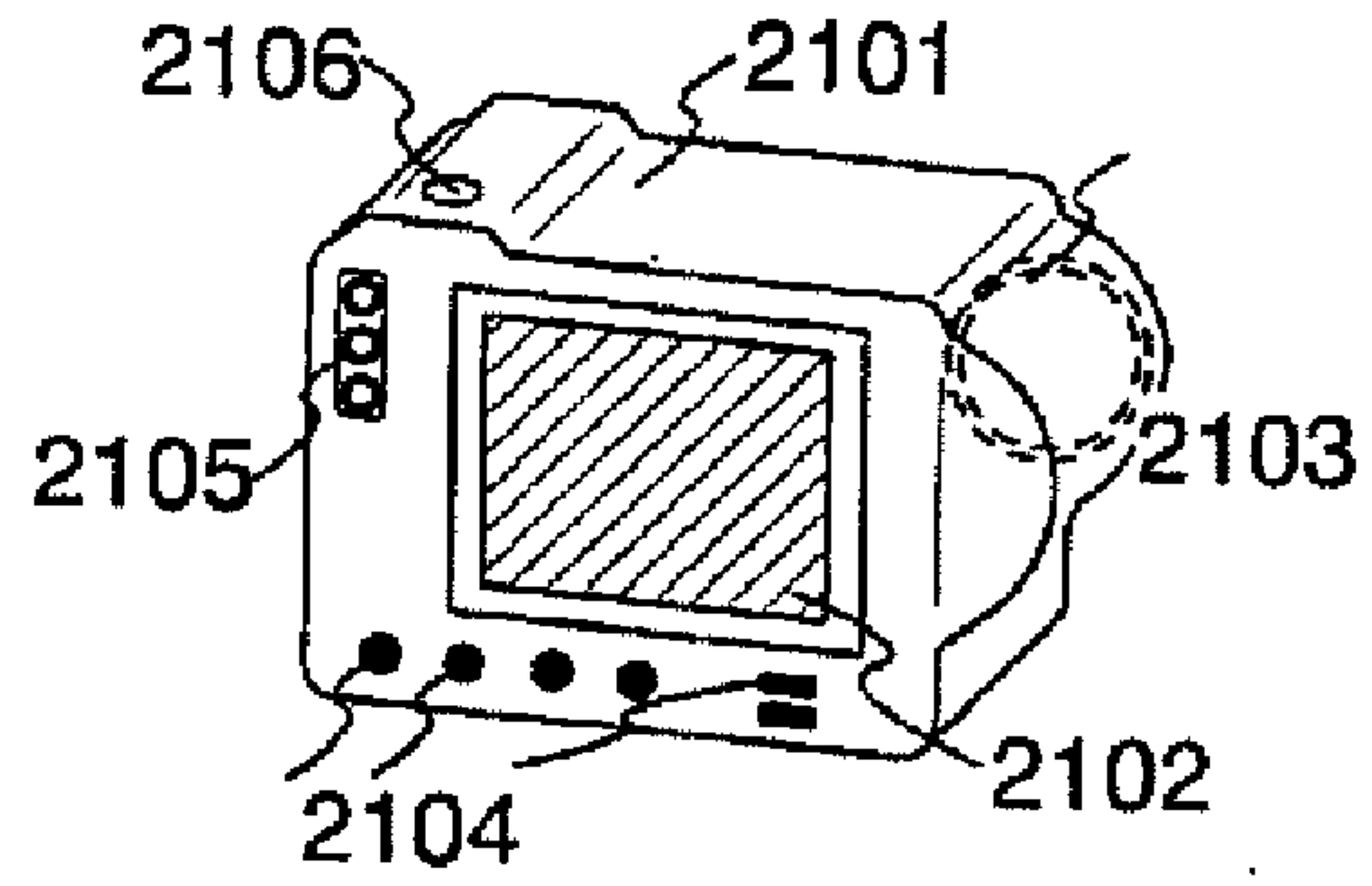


FIG. 9B

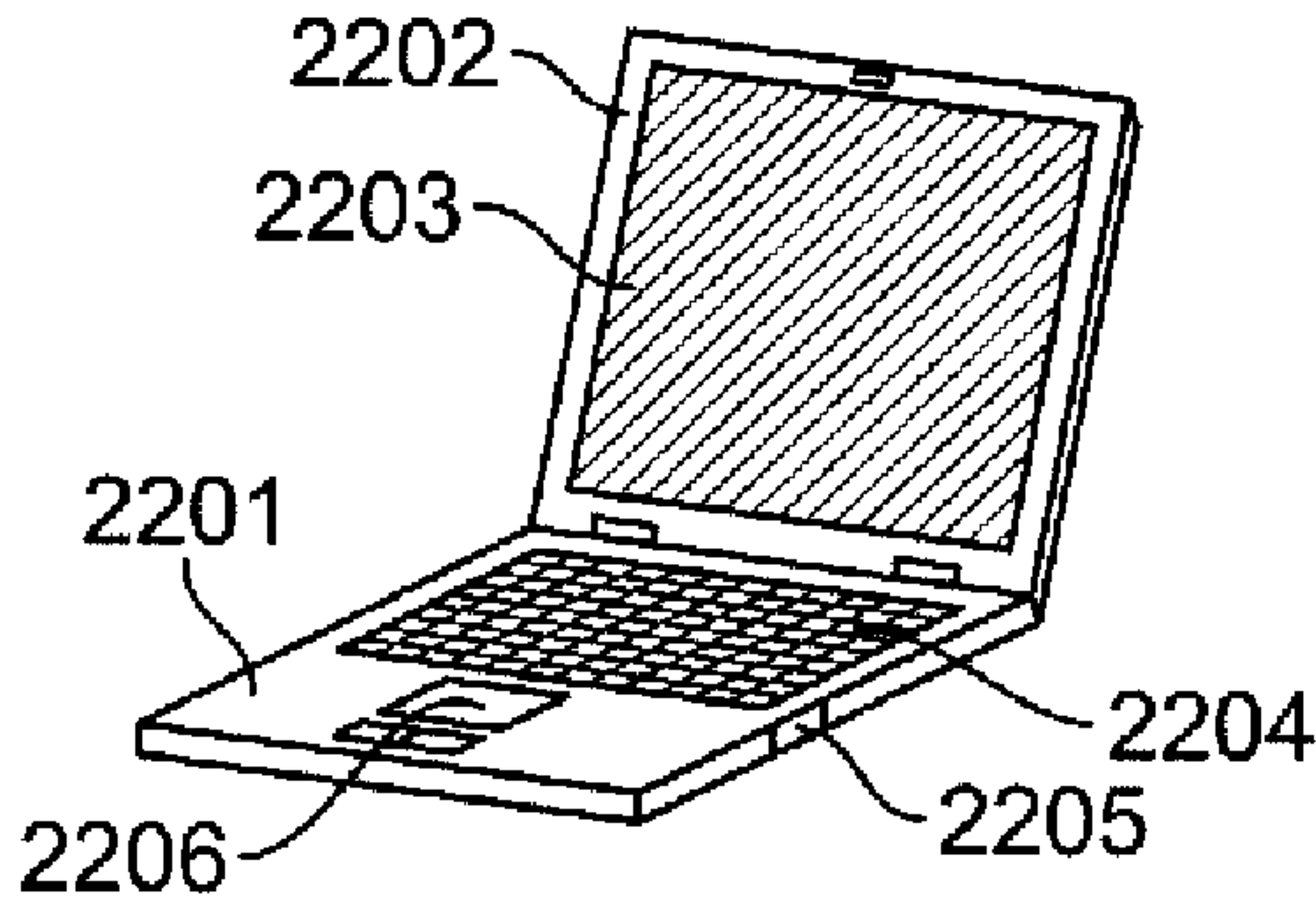


FIG. 9C

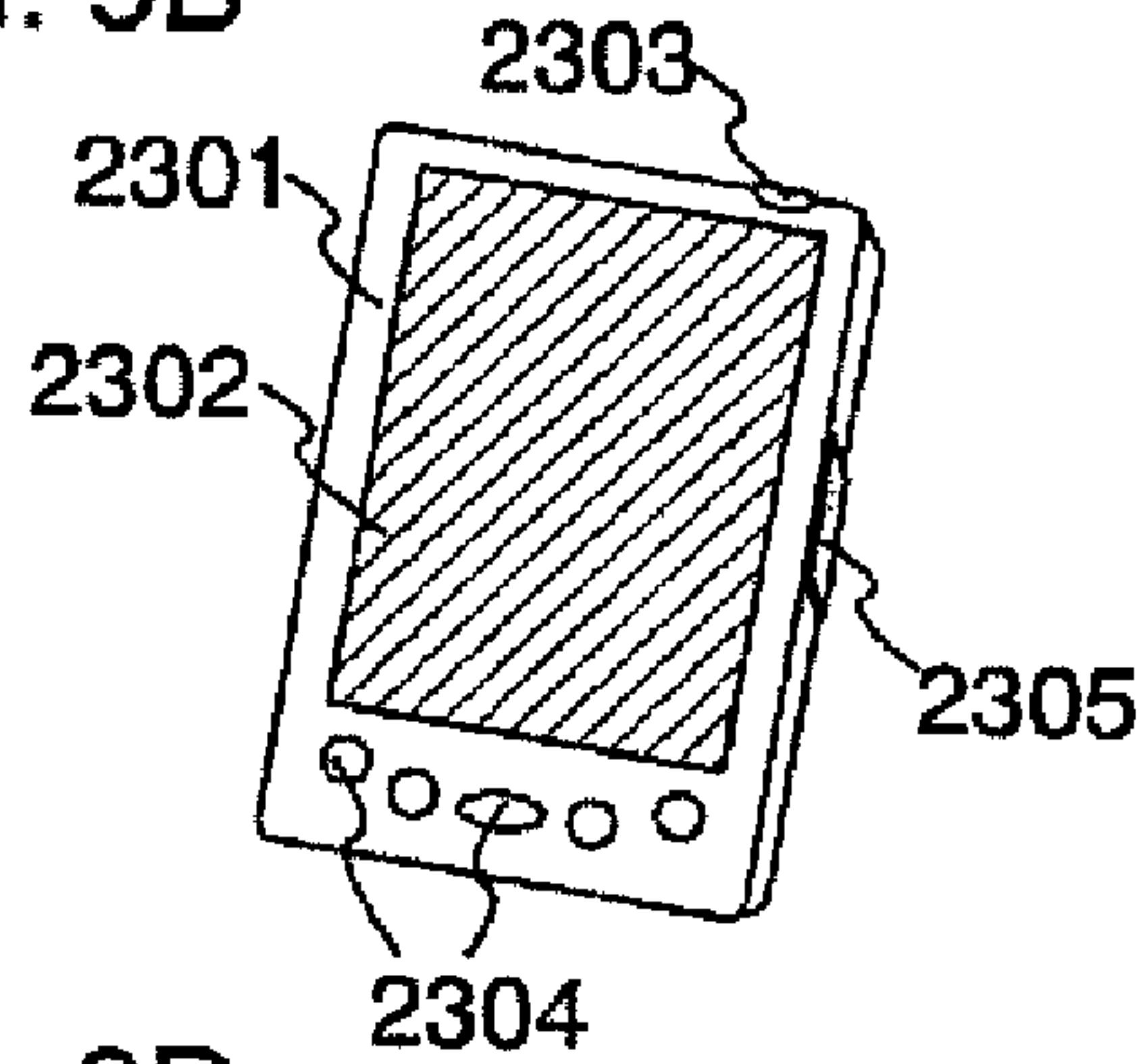


FIG. 9D

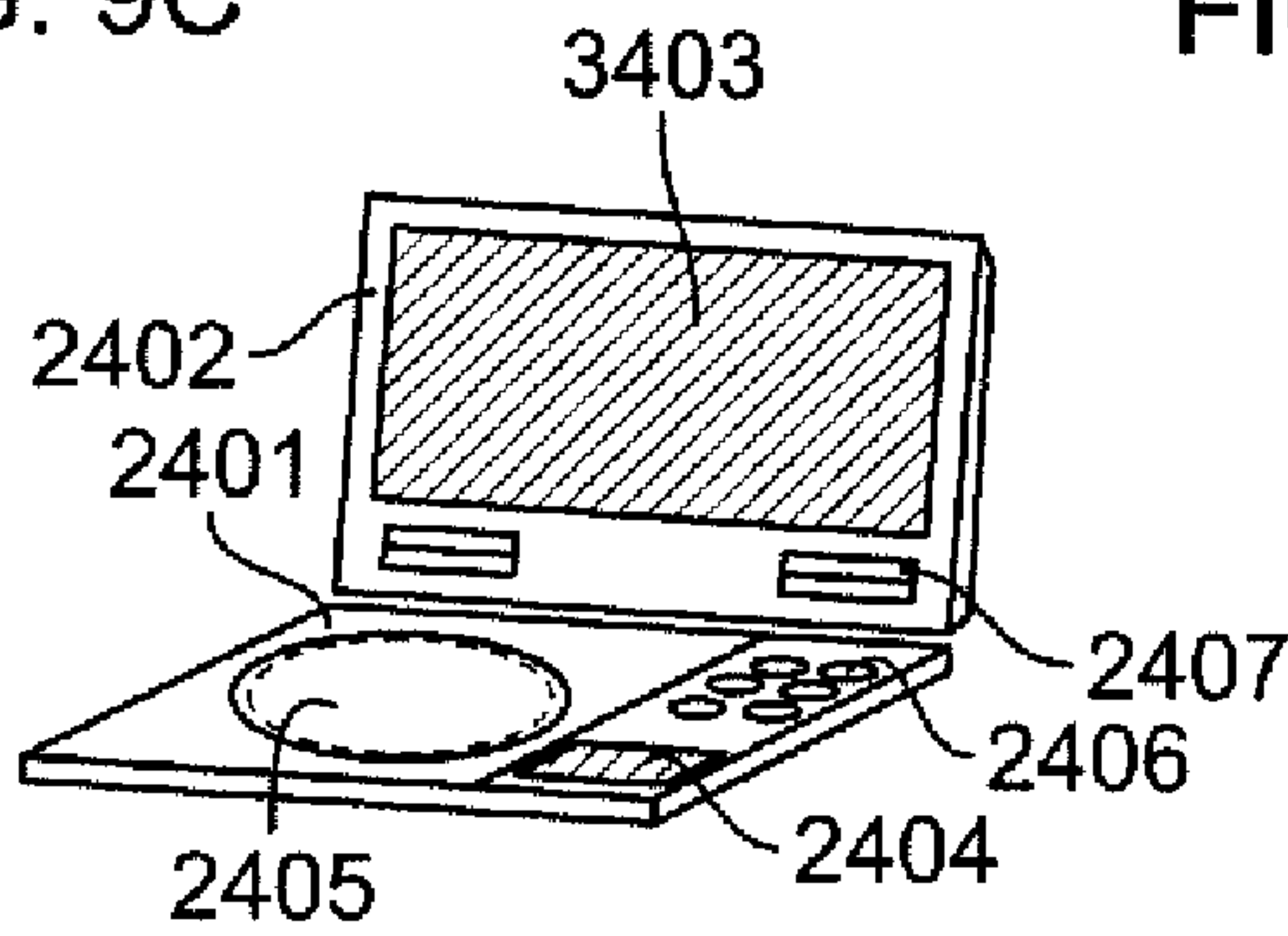


FIG. 9E

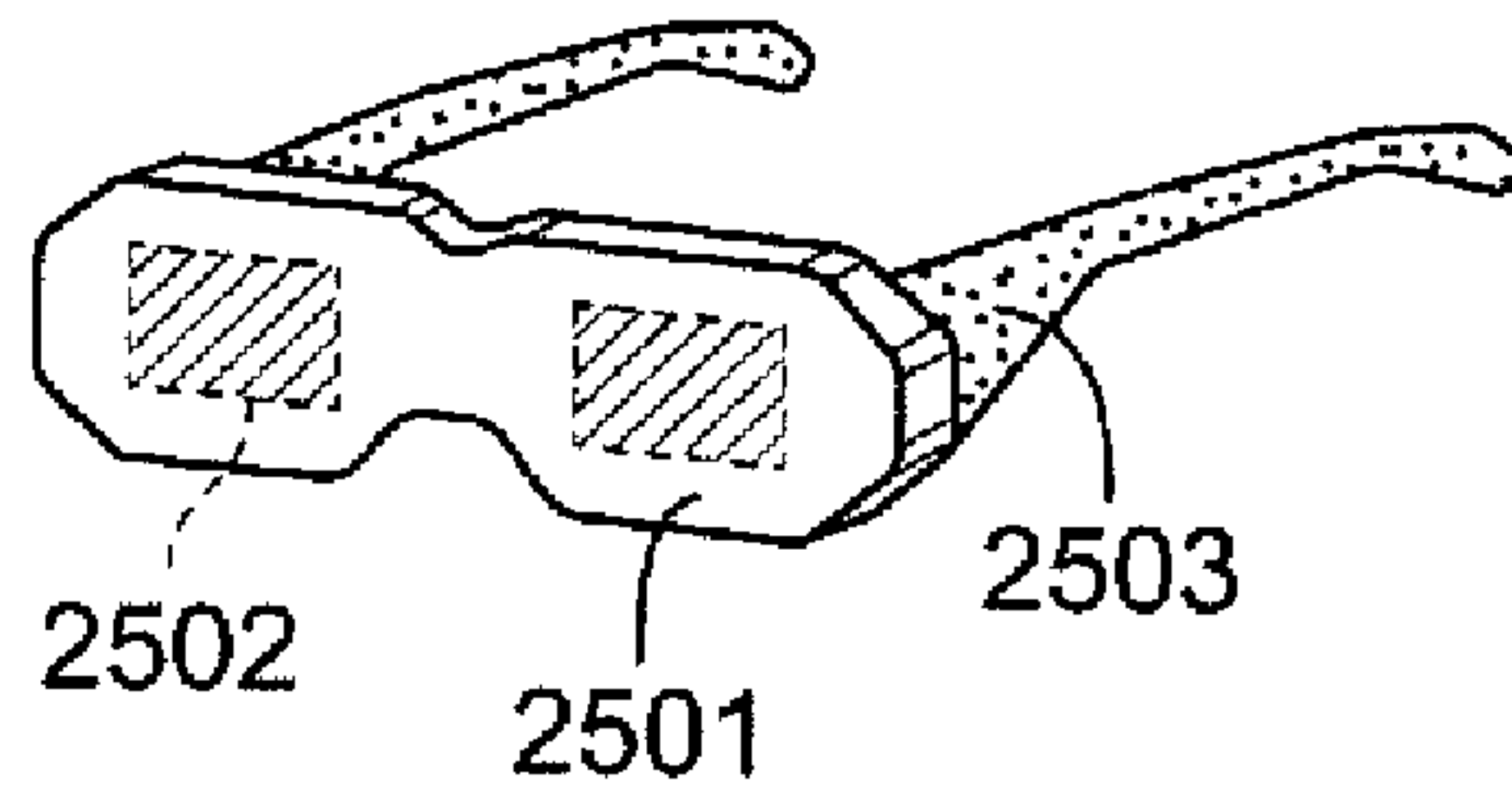


FIG. 9F

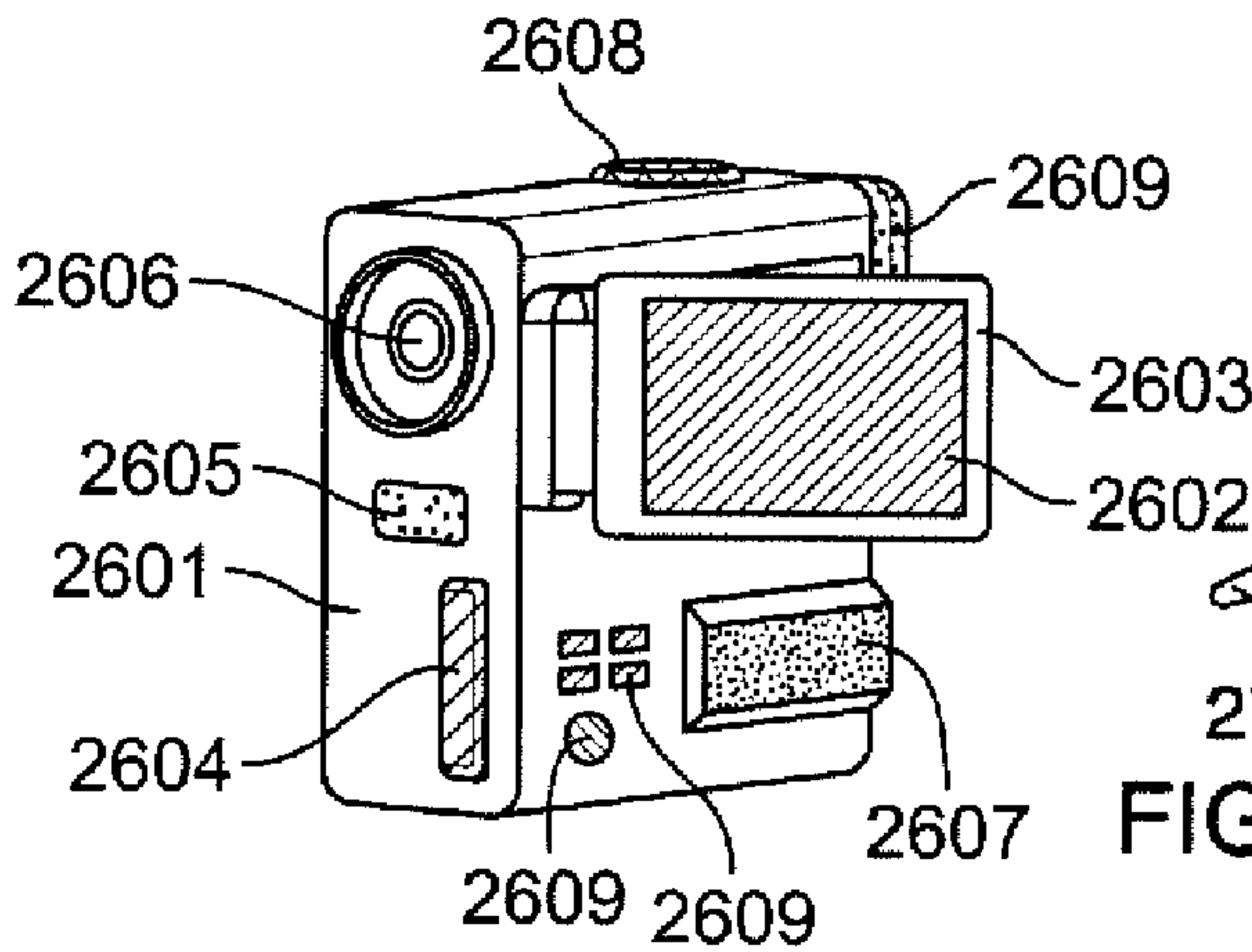


FIG. 9G

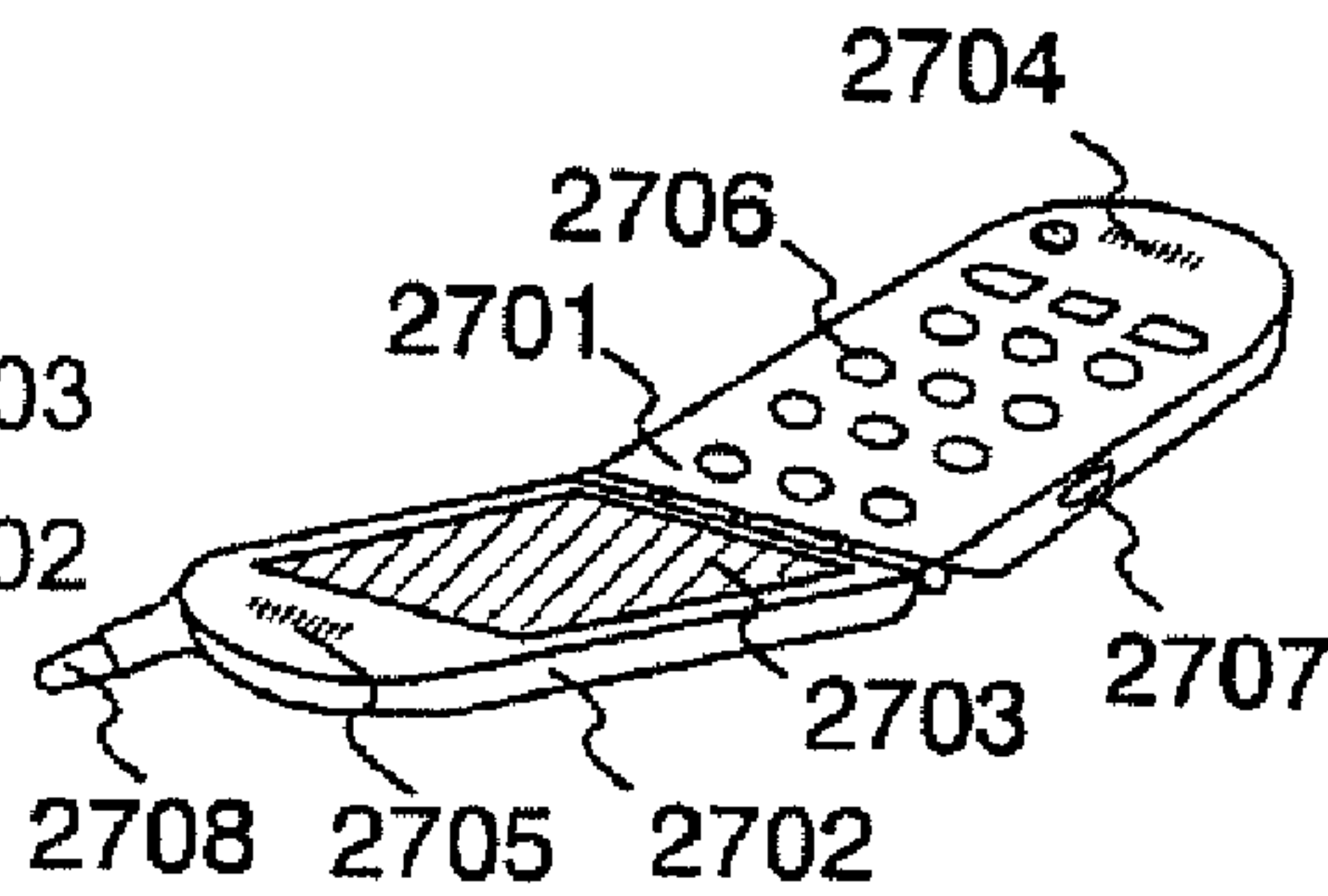


FIG. 9H

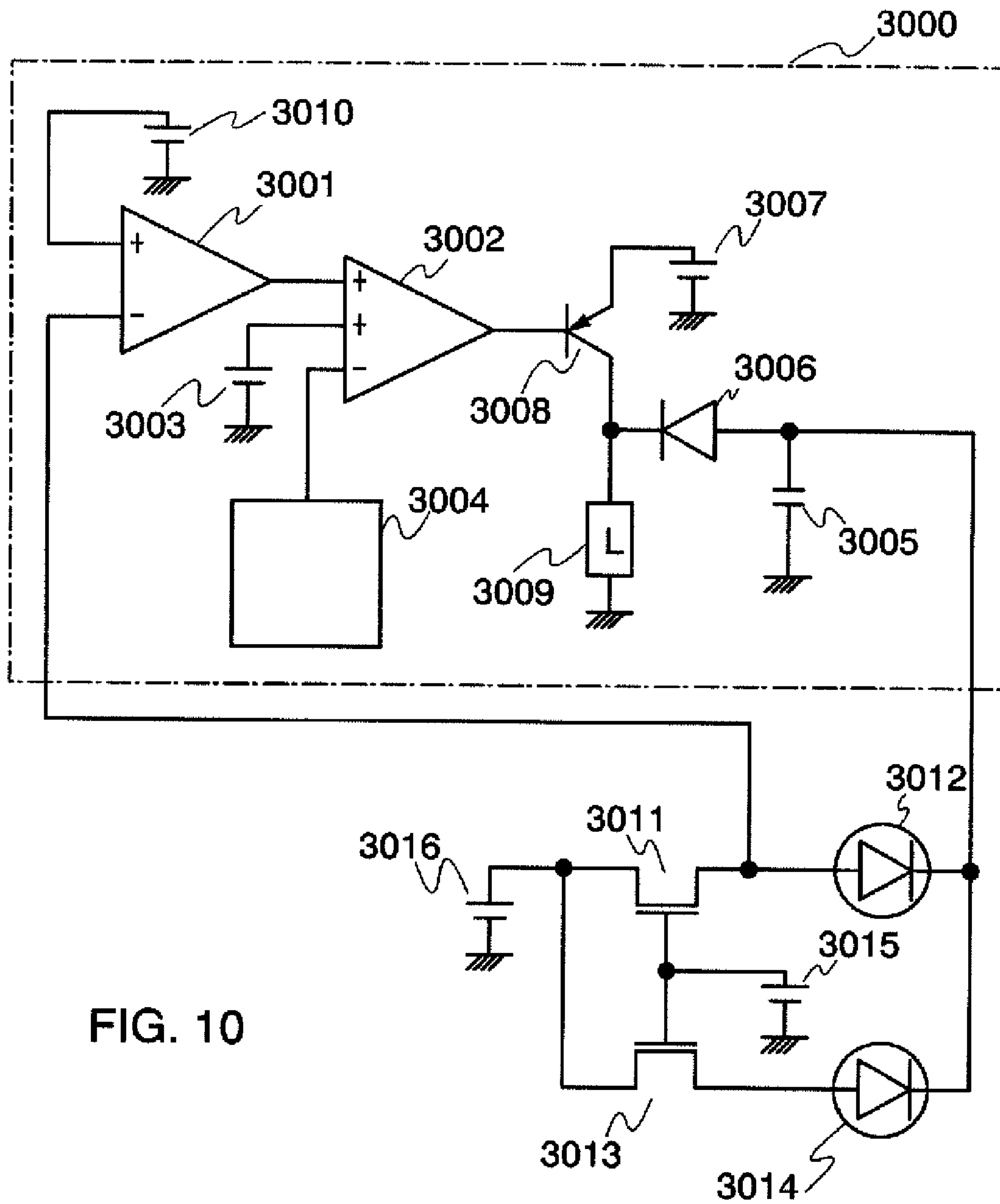


FIG. 10

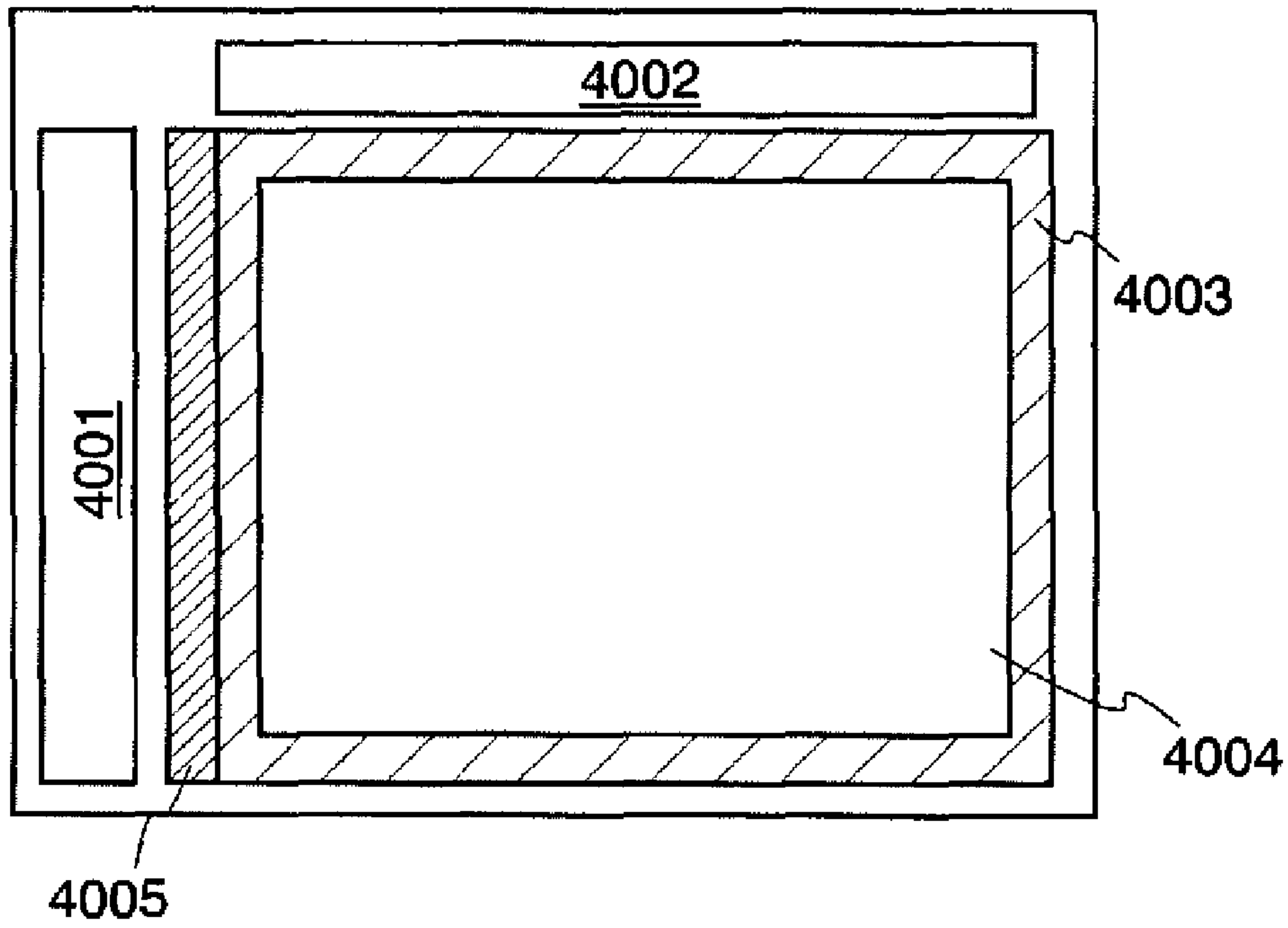


FIG. 11A

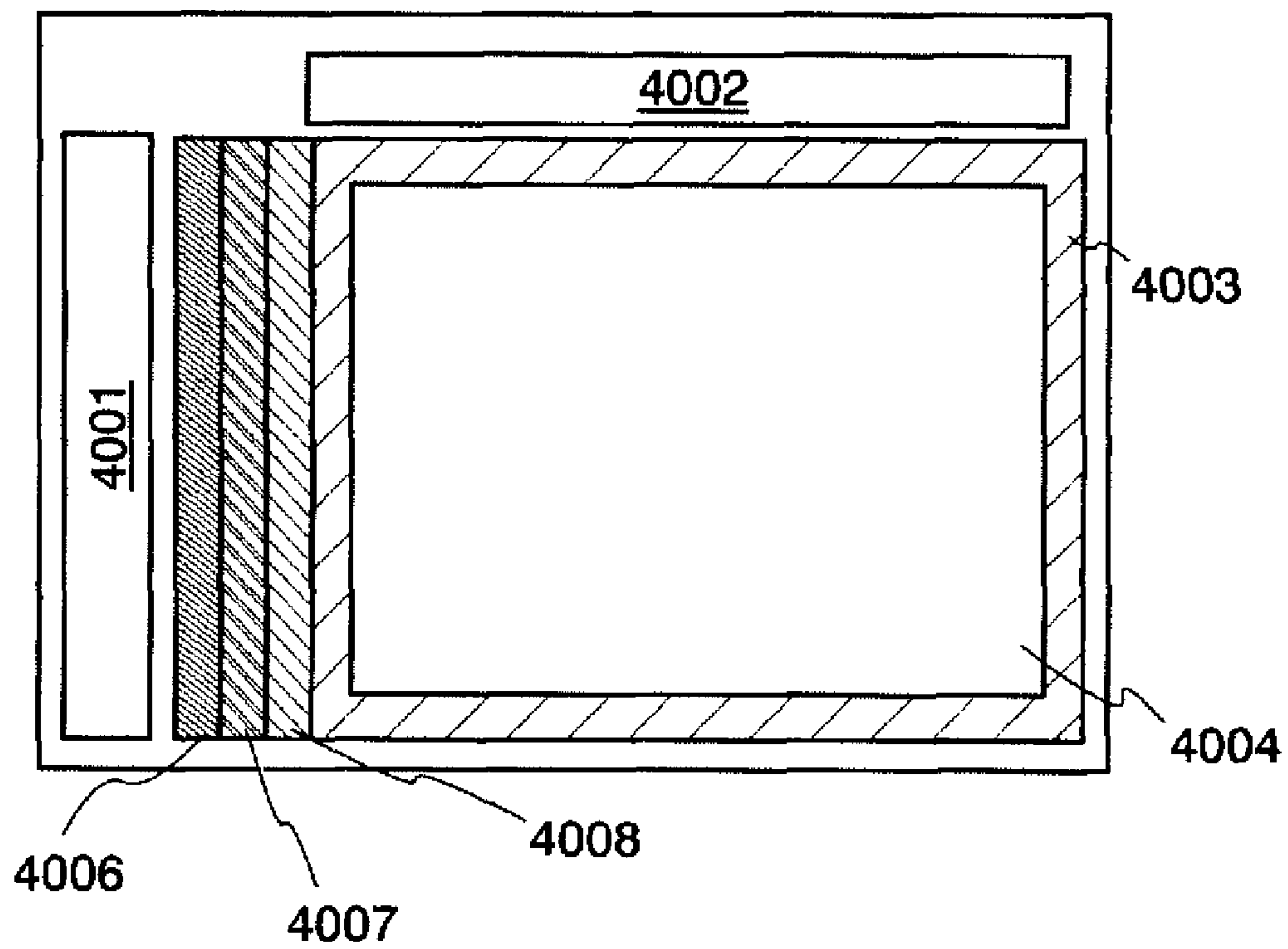


FIG. 11B

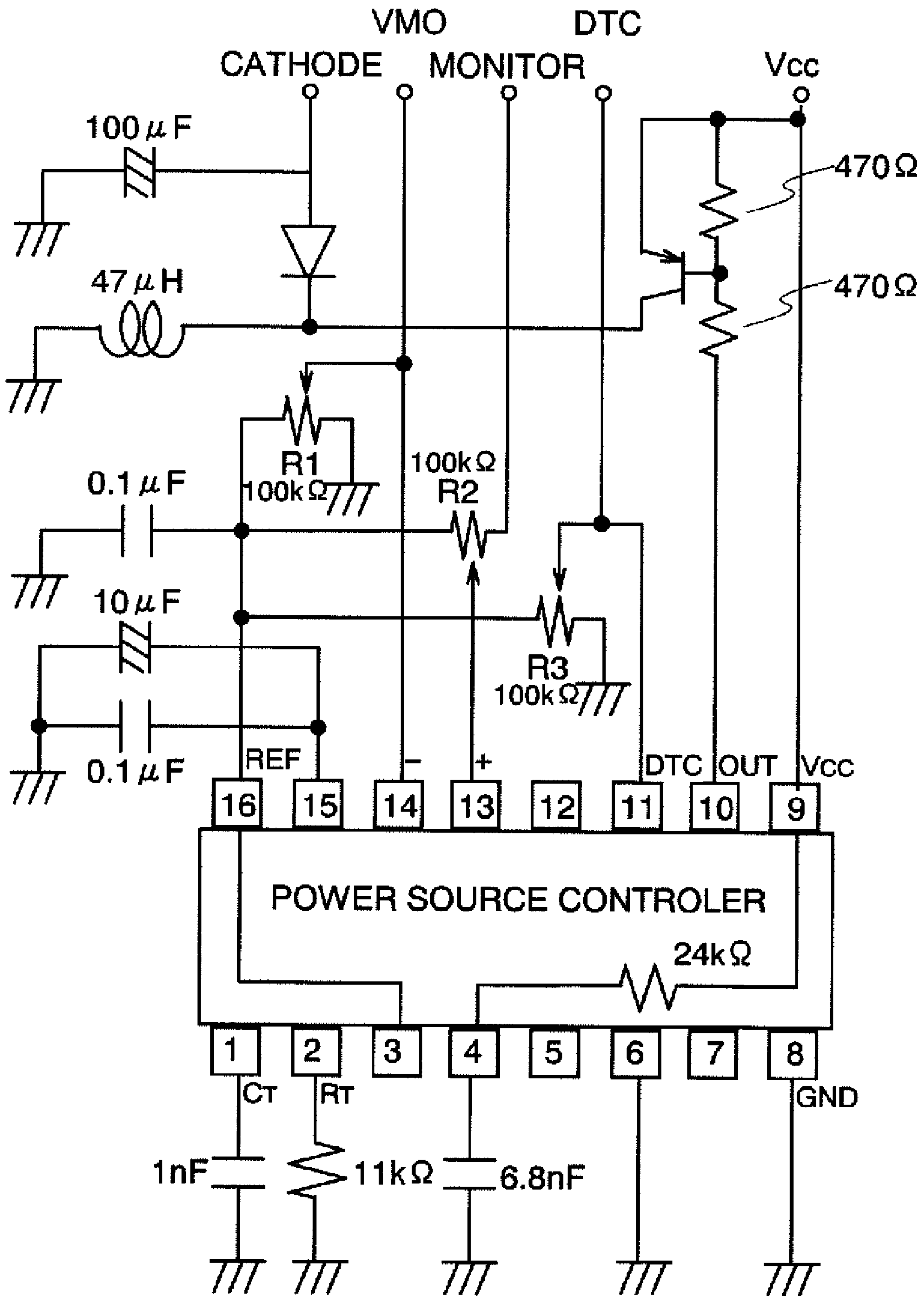


FIG. 12

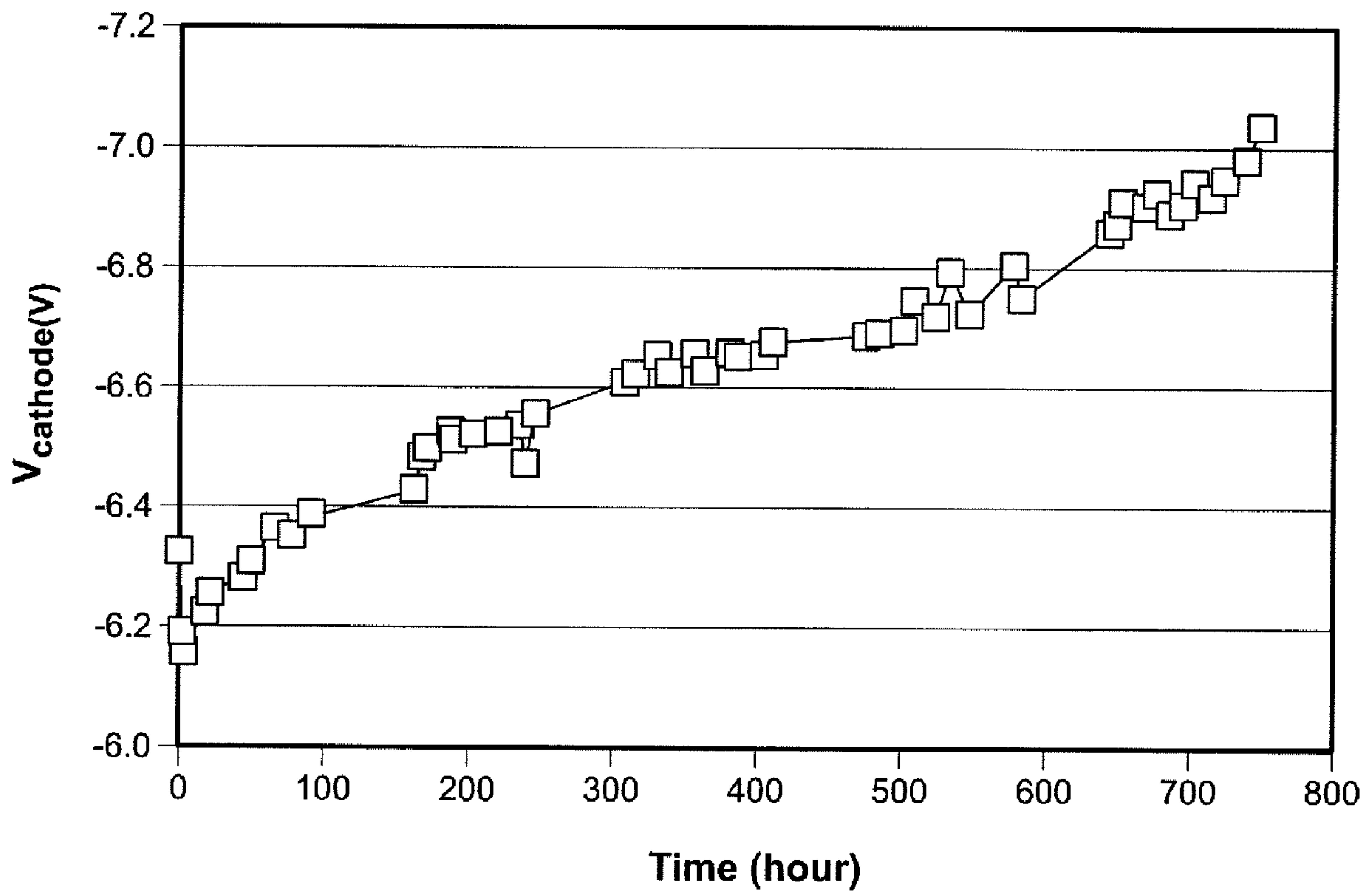


FIG. 13

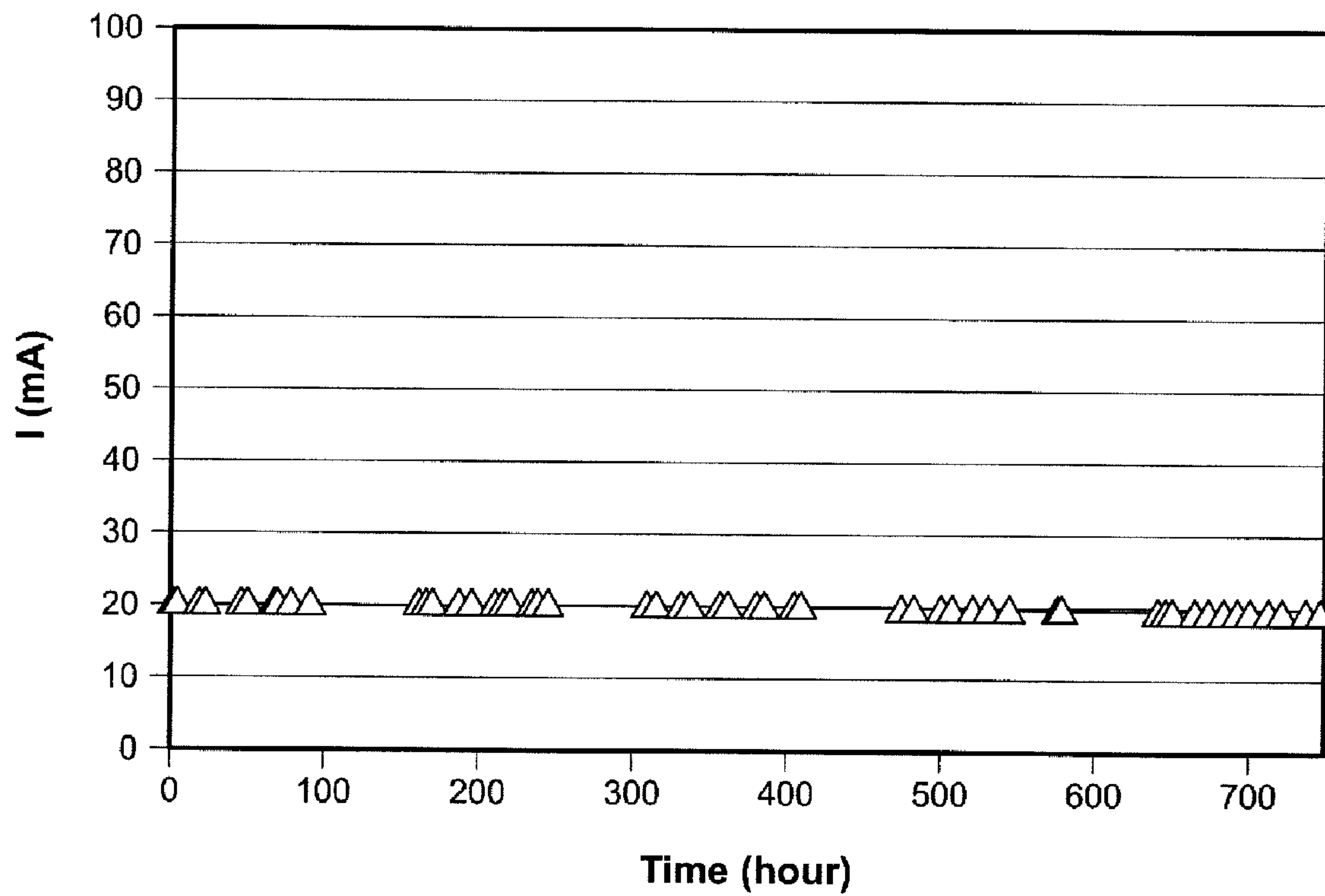


FIG. 14

DISPLAY DEVICE AND CONTROLLING METHOD THEREOF

CROSS-REFERENCE TO RELATED APPLICATIONS

This application is a divisional of U.S. application Ser. No. 12/255,235, filed Oct. 21, 2008, now allowed, which is a continuation of U.S. application Ser. No. 11/675,116, filed Feb. 15, 2007, now U.S. Pat. No. 7,453,453, which is a continuation of U.S. application Ser. No. 10/697,003, filed Oct. 31, 2003, now U.S. Pat. No. 7,180,515, which claims the benefit of a foreign priority application filed in Japan as Serial No. 2002-318974 on Oct. 31, 2002, all of which are incorporated by reference.

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to a display device (light emitting device) having a light emitting element, and more particularly such a display device having a display part of current driving method.

2. Description of the Related Art

Digital gradation method (digital driving method) and analog gradation method (analog driving method) can be given as driving method of multi-color expression on a display device having a light emitting element. In the aforementioned digital gradation method, a light emitting element is driven in binary of ON (brightness is almost 100%) and OFF (brightness is almost 0%) to obtain gradation by controlling the luminous region and the length of the period during which each pixel emits light. In the analog gradation method, analog input data is written into a light emitting element to modulate the gradation in an analog manner.

Furthermore, expression of gradation is made through two methods, which are a constant voltage drive which is dependent on the voltage applied to the light emitting element, and a constant current drive which is dependent on the current applied to the light emitting element. An electric current flowing through a light emitting element is controlled by a transistor (hereinafter referred to as driver transistor) in current drive.

Operation of a driver transistor is explained referring to the V-I feature shown in FIG. 8. There are two operating regions of the driver transistor, namely, a saturation region and a linear region.

Linear region is a region of which current value changes according to the voltage between the source and drain (V_{ds}) and the voltage between the gate and source (V_{gs}). ($|V_{ds}| < |V_{gs} - V_{Th}|$) In the linear region, the following expression (1) is established. Note that I_{ds} is the amount of current running through a channel forming region. Note also that $\beta = \mu C_o \cdot W/L$ is established and μ thereof is a mobility of the driver transistor, C_o is a gate capacity per unit volume, and W/L is a ratio of the channel width W to the length L in channel forming region.

$$I_{ds} = \beta \{ (V_{gs} - V_{Th}) V_{ds} - 1/2 \cdot V_{ds}^2 \} \quad (1)$$

According to the expression (1) above, V_{ds} and V_{gs} obtain the current value in the linear region. In the linear region, the lesser V_{ds} becomes, the lesser current value becomes too, while the current value hardly increases even if V_{gs} gets larger.

When the driver transistor is operated in mainly the linear region, the amount of current flowing between both electrodes of the light emitting element is changed according to

both values of V_{gs} and V_{ds} . The driver transistor is used as a switch, and a power source line and the light emitting element are shorted if necessary, thereby flowing a current into the light emitting element. The current value flowing through the light emitting element is directly influenced by the characteristics (variation and deterioration in the manufacturing process) of the light emitting element that is connected to the driver transistor.

In the saturation region, the current value is not changed by the voltage between the source and drain (V_{ds}), in other words, it is only changed by the voltage between the gate and source (V_{gs}). ($|V_{ds}| > |V_{gs} - V_{Th}|$)

In the saturation region, the following expression (2) is established.

$$I_{ds} = \beta (V_{gs} - V_{Th})^2 \quad (2)$$

As set forth in the expression (2), the current value in the saturation region is greatly dependent on a change in V_{gs} but not dependent on a change in V_{ds} . Therefore, the current value in the saturation region is not influenced by the characteristics of the light emitting element connected to the driver transistor.

On the other hand, when the driver transistor is operated in mainly the saturation region, the amount of current flowing between both electrodes of the light emitting element is greatly dependent on a change in V_{gs} of the driver transistor but not dependent on a change in V_{ds} . A gate voltage of the driver transistor is controlled to flow the necessary amount of current into the light emitting element. In other words, the driver transistor is used as a voltage control current source and the driver transistor is set such that a constant current flows between a power source line and the light emitting element.

In the constant current drive utilizing the abovementioned feature, the current value is not dependent on a change in V_{ds} when the driver transistor is operated in the saturation region. Therefore, the amount of current flowing into the light emitting element can be constant regardless of the characteristics (variation in the manufacturing process, deterioration, and temperature variation) of the light emitting element.

When V_{gs} of a driver transistor is changed appropriately, the driver transistor can be operated in mainly a linear region or in mainly a saturation region.

Operating a driver transistor in the saturation region as shown above is disclosed in patent document 1.

[Patent Document]

Japanese Patent Laid-Open No. Hei 14-108285

In the abovementioned constant current drive, an operating region of a transistor steps into the linear region once V_{ds} thereof is decreased to a certain point by the deterioration of an light emitting element. To avoid this, a setting voltage of V_{ds} (V_{ds} of a driver transistor in operation) is set with an estimated deterioration (voltage for deterioration, voltage α) of the light emitting element. The voltage α is dependent on the deterioration of the light emitting element.

In a conventional setting voltage, in short, V_{ds} needed to be set high because of the estimated value (812) for the margin of the change in characteristics of a light emitting element between before (810) and after (811) deterioration. ($|V_{ds}| \geq |V_{gs} - V_{Th} + \alpha|$)

The voltage applied to the cathode and anode of a light emitting element thus became inevitably high, causing heat generation and high power consumption.

It is an object of the invention to provide a pixel structure which can be operated without adding the voltage α to the setting voltage for the deterioration of the light emitting element. Namely, a pixel structure with the setting voltage in the vicinity of the boundary between the saturation region and the

linear region (813 in FIG. 8) is to be provided. A further object of the invention is to provide a display device provided with an aforementioned pixel and a control method thereof.

SUMMARY OF THE INVENTION

The present invention has been made in view of the above problems, and has an object thereof to modify a setting voltage by providing a power source voltage controller which feedbacks the change in current value in accordance with the deterioration of the light emitting element and sets the setting voltage thereby. Therefore, the setting voltage in the vicinity of the boundary between the saturation region and the linear region is to be provided, without the margin of voltage α for the deterioration particularly in the initial setting voltage.

To put it concretely, the invention utilizes an element to check the deterioration of a light emitting element (hereinafter referred to as a monitoring element) and controls the power source voltage in accordance with the deterioration of the monitoring element. That is, voltage between the source and drain is modified to a constant value by fixing the potentials of a gate electrode and source electrode of the driver transistor of the monitoring element and controlling the potential of a drain electrode (drain terminal) in accordance with the deterioration of the light emitting element.

FIG. 1 is a pattern diagram of the structure of the invention, showing a pixel portion 103 having a monitoring element 101 and a pixel 102. The monitoring element 101 has a light emitting element and a driver transistor connected to the pixel. The pixel 102 also has a light emitting element and a driver transistor connected to the pixel. The invention has a first electrode 104 and a second electrode 105 connected to the monitoring element 101 and the pixel 102. A potential of the first electrode is shown as V_1 , and a potential of the second electrode is shown as V_2 . Note that a monitoring element may be set up at any part including outside of the pixel portion.

Furthermore, the invention has a power source voltage controller 106 so as to keep the current value constant by recognizing the change in current value in accordance with the deterioration of a monitoring element. Namely, the change in current value with the deterioration of the monitoring element 101 is fed back to the power source voltage of the pixel, fixing the potential of the first electrode: V_1 , and changing the potential of the second electrode: V_2 . As the second electrode 105 is connected to the monitoring element 101 and the pixel 102, current value of the pixel 102 is kept constant by changing V_2 .

Concerning FIG. 1, a layout of the pixel and monitoring element and the structure of the elements are to be identical, while connections (with or without connections) may vary. Concerning the invention, however, the structures of the pixel and the monitoring element do not necessarily have to be identical. However, in the case of forming the monitoring element with the identical structures and different connections, manufacture thereof can be easier as there is no need to change the process but only the design of contacts and the like need to be changed.

Operation to control the power source voltage is now explained with reference to the flow chart, FIG. 2.

First, voltage to apply to the light emitting elements of the monitoring element and a pixel is set (driving voltage of light emitting elements). At this time, the driver transistor is set to operate in the saturation region, but the deterioration margin (voltage α) is not necessarily needed. That is, the voltage α which was conventionally necessary can be unnecessary or reduced according to the invention.

After that, a signal is inputted to the monitoring element and the light emitting element of the pixel to emit light. The gradation expression method to express multicolor at pixels may be either time gradation method or analog gradation method.

The light emitting element of the pixel as well as of the monitoring element deteriorate gradually as time passes. As the light emitting elements of the pixels at this time are expressing gradations, few of them emit light constantly. On the other hand, a light emitting elements of the monitoring elements are controlled to emit light at all time. That is, the light emitting element of the monitoring element deteriorates the fastest. Taking that into account, the power source voltage is controlled to set the setting voltage in accordance with the deterioration of the light emitting element of the monitoring element. In this way, the setting voltage can be modified in consideration of the deterioration of the light emitting element of the pixels.

Deterioration of the light emitting element of the monitoring element raises the resistance value of the light emitting element, lowers I_{ds} of the driver transistor, and reduces V_{ds} of the driver transistor. At this time, the setting voltage is to be adjusted by a power source voltage controller to bring the current value to the setting current. That is, V_2 is to be reduced and the voltage applied to the light emitting element is to be raised. Furthermore, the monitoring element and the pixel have the same V_2 , so that the setting voltage of the pixel is modified simultaneously.

It is to be noted that in the invention, the power source voltage may be controlled by recognizing the change in voltage value or the characteristics in accordance with the deterioration of the monitoring element. The power source voltage may also be controlled by the other changes besides the changes in voltage value and current value in accordance with the deterioration of the monitoring element.

As described above, the invention enables the driver transistor to operate in the saturation region without adding the deterioration margin (voltage α) to the setting voltage when the light emitting element starts emitting light. Therefore, the margin of the setting voltage due to the deterioration of the light emitting element is not needed anymore. In general, the voltage α for the deterioration margin is estimated at 2 to 6V, which causes the driving voltage to decrease as much. As a result, heat generation and high power consumption at pixels can be avoided. As heat generation of the driver transistor can be reduced particularly, the deterioration of the light emitting element can be reduced.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a pattern diagram of a pixel portion of the invention.

FIG. 2 is a flow chart showing an operation of a display device of the invention.

FIGS. 3A and 3B are pattern diagrams of a pixel portion of a display device of the invention.

FIG. 4 is a pattern diagram of a pixel portion of a display device of the invention.

FIG. 5 is an equivalent circuit diagram of a pixel portion of a display device of the invention.

FIG. 6 is a top plan view of a pixel portion of a display device of the invention.

FIGS. 7A and 7B are top plan views of a display module of the invention.

FIG. 8 is a view showing a V-I feature of a transistor.

FIGS. 9A to 9H are views showing electronic apparatuses having pixel portions of display devices of the invention.

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FIG. 10 is a pattern diagram of a pixel portion of a display device of the invention.

FIGS. 11A and 11B are pattern diagrams of a pixel portion of a display device of the invention.

FIG. 12 is a view showing an experimental circuit of the invention.

FIG. 13 is a chart showing a change of an anode potential ($V_{cathode}$) with the passage of time (hour).

FIG. 14 is a chart showing a current value (I) which is supplied to a light emitting element with the passage of time (hour).

DESCRIPTION OF THE PREFERRED EMBODIMENTS

Preferred embodiments of the invention will be hereinafter described referring to the accompanying drawings. Note that an active element has a gate, a source and a drain, but it is impossible to distinguish a source electrode and a drain electrode because of the element structures. Therefore, when a connection between the terminals is explained, either of the source electrode or the drain electrode is referred to as a first electrode, and the other is referred to as a second electrode for convenience.

Embodiment Mode 1

Hereinafter explained with reference to FIG. 3 is an example in which an operational amplifier is used as a power source voltage controller. Note that in this embodiment mode, a p-channel type driver transistor is applied, but an n-channel type driver transistor can be applied instead. Meanwhile, as an example of the invention, an anode potential of a pixel 311 (V_{anode}) is referred to as V_1 , and cathode potentials of the pixel 311 and of a monitoring element 301 ($V_{cathode}$) are referred to as V_2 .

FIG. 3A shows an equivalent circuit diagram of a pixel structure of the invention. A monitoring element 301 has a driver transistor 302 and a light emitting element 303 which is connected to a second electrode of the driver transistor 302. A pixel 311 has a driver transistor 312 and a light emitting element 313 which is connected to a second electrode of the driver transistor 312. The light emitting elements 303 and 313 are connected to an output terminal of the operational amplifier 320 and have a voltage of V_2 . Meanwhile, first electrodes of the driver transistors 302 and 312 have potential V_1 which is the same potential as the electrodes of the light emitting elements.

A non-inverted input terminal (+side) of the operational amplifier 320 is connected to the first electrode of the driver transistor 312 of the pixel, and an inverted input terminal (-side) is connected to the first electrode of the driver transistor 302 of the monitoring element. The driver transistor of the monitoring element is connected to a reference power source (V_{ref}) via a resistance (R). Note that V_{ref} is higher than V_1 (V_{anode}).

Next, a method for setting a voltage of the driver transistor of the monitoring element (V_{ds}) is explained.

First, V_1 (namely, V_{anode} of the monitoring element) is set on the basis of a specification of a display device. Specifications of general display devices prescribe V_1 as 2 to 6V. A gate voltage of the driver transistor 302 (V_{moni}) is set so that a predetermined current (I_{ref}) can flow in the monitoring element in a saturation region. Then, a gate voltage of the driver transistor 312 (V_{pix}) is set at the same value or higher than V_{moni} .

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Next, the reference power source V_{ref} and the resistance value R are set so that the predetermined current (I_{ref}) can flow in the monitoring element 301 and the driver transistor 302 can operate in a saturation region. Note that other means to supply a predetermined current which flows in the monitoring element can be used besides the reference power source V_{ref} and the resistance R. For example, the predetermined current (I_{ref}) can be supplied by a current source 321 as shown in FIG. 3B.

Namely, the values of V_1 , V_{ref} , V_{moni} , V_{pix} , and R are determined by a practitioner and I_{ds} of the driver transistor 302 of the monitoring element is controlled externally.

As described above, a display operation is started by setting the monitoring element (called an operation state or a driving state). After that, the light emitting element 303 of the monitoring element deteriorates as time passes. Similarly, the light emitting element 313 of the pixel deteriorates. Further, due to the deterioration of the light emitting element, the resistance value becomes high, thus a current value flowing in the monitoring element becomes low.

The operational amplifier will be hereinafter explained. The operational amplifier 320 basically functions with an input potential of approximately 0 and with a non-inverted input terminal and an inverted input terminal, the voltages of which are approximately the same. Accordingly, the following expression is established.

$$I_{ref} = (V_{ref} - V_1) / R = (V_1 - V_2) / R_{moni}$$

$$\therefore V_2 = (R_{moni} / R + 1) \cdot V_1 - (R_{moni} / R) \cdot V_{ref}$$

R_{moni} is a resistance value between the first electrode of the driver transistor 302 and the power source side of the light emitting element 303. The operational amplifier changes the value of V_2 when R_{moni} is changed and keeps the I_{ref} value constant.

Such an operational amplifier modifies a setting voltage and further modifies V_{ds} of the driver transistor of the pixel because the monitoring element and the pixel has V_2 ($V_{cathode}$) in common.

Meanwhile, in this embodiment mode, V_{ds} is set in a saturation region even when electric characteristics of the driver transistor are changed by the temperature or the like because I_{ds} is determined and controlled by the operational amplifier.

Hereinafter, the setting current of the monitoring element will be complimented in view of the difference of the deteriorating speeds between the pixel and the light emitting element.

In the case of a digital gradation method for example, the light emitting element of the pixel repeatedly performs the light emission and non-light emission (erasure) on the basis of a signal current (video signal). Meanwhile, the light emitting element of the monitoring element constantly emits light. Therefore, the light emitting element of the monitoring element deteriorates faster than that of the pixel. That means the deterioration of the light emitting element of the monitoring element is the fastest of all.

Namely, a voltage with an estimated deterioration of the light emitting element can be set in the driver transistor of every pixel when V_{ds} of the driver transistor is set by the operational amplifier so that the deterioration of the light emitting element of the most deteriorated monitoring element can be offset. Therefore, it is not required to control the light emitting element of the monitoring element corresponding to the light emission and non-light emission of the light emitting element of the pixel.

However, preferably required is the case where a light emission ratio of the light emitting element of the pixel per

frame (duty ratio) is figured, and the light emitting element of the monitoring element are made to emit light in accordance with the duty ratio. Namely, in the case of the digital gradation system, the setting current of the monitoring element is preferably set at (current value during the light emission×duty ratio).

In the case of an analog gradation method, the gradation is controlled by the amount of the current which flows into the light emitting element as described above. Therefore, in the analog gradation system, a current value over the average of the pixel with the maximum light emission is preferably required.

That is to say, according to the invention, it is possible to obtain a setting voltage with an estimated deterioration of the light emitting elements of all the pixels by measuring the deterioration of the monitoring elements and setting the setting voltage of the monitoring elements in the saturation region.

Further, the deterioration ratio of the light emitting elements is different depending on the materials: red (R), green (G) and blue (B). In this case, by taking the deterioration of the light emitting elements of the monitoring elements equal to or more than the most deteriorated element of each light emitting element, V_2 ($V_{cathode}$) can have a sufficient value.

As above, according to the invention, it is possible to obtain a setting voltage without a deterioration margin (voltage a). Accordingly, a margin of the setting voltage in accordance with a deterioration of a light emitting element is not required, thus heat generation and power consumption can be reduced. Particularly, by the reduction in power consumption of the driver transistor, the deterioration of the light emitting element can be prevented.

Embodiment Mode 2

Hereinafter explained with reference to FIG. 4 is a different pixel structure from that of Embodiment Mode 1. Note that in this embodiment mode, a driver transistor is a p-channel type, an anode potential of a light emitting element (V_{anode}) is referred to as V_1 , and a cathode potential of the light emitting element ($V_{cathode}$) is referred to as V_2 .

An equivalent circuit diagram of a pixel structure is shown in FIG. 4. As well as Embodiment Mode 1, a monitoring element 401 has a driver transistor 402 and a light emitting element 403 which is connected to a second electrode of the driver transistor 402. A pixel 411 has a driver transistor 412 and a light emitting element 413 which is connected to a second electrode of the driver transistor 412. The light emitting elements 403 and 413 are connected to an output terminal of the operational amplifier 420 and have a voltage of V_2 . Meanwhile, first electrodes of the driver transistors 402 and 412 have potential V_1 which is the same potential as the electrodes of the light emitting elements.

Unlike Embodiment Mode 1, a non-inverted input terminal (+side) of the operational amplifier 420 is connected to a bias power source V_b , and an inverted input terminal (-side) is connected to the interconnection between the driver transistor of the monitoring element 402 and the light emitting element 403.

Next, a method for setting a voltage of the driver transistor of the monitoring element (V_{ds}) is explained.

First, V_1 is set on the basis of a specification of a display device. Then, a gate voltage of the driver transistor 402 (V_{moni}) is set so that a predetermined current (I_{ref}) can flow in the monitoring element in a saturation region. Also, a gate voltage of the driver transistor 412 (V_{pix}) is set at the same value as or higher than V_{moni} .

Next, V_b is determined so that the driver transistor 402 of the monitoring element can operate in a saturation region. Namely, V_{ds} of the driver transistor is determined. As described above, a current which flows in the monitoring element 401 is determined by the operational amplifier and V_2 ($V_{cathode}$) is determined so that the current which flows in the monitoring element 401 can flow in the light emitting element 403.

Namely, the values of V_1 and V_b are determined externally and V_{ds} of the driver transistor of the monitoring element is controlled.

When a display operation is started by setting as above, a resistance value rises due to the deterioration of the light emitting element. Then, with the current value flowing in the monitoring element lowered, V_{ds} of the driver transistor 402 also tries to lower itself. However, V_{ds} is held constant because the potential difference between the input terminals of the operational amplifier is ideally 0. Then, I_{ds} becomes constant because V_{gs} and V_{ds} are constant, thus V_2 is automatically selected by I_{ds} .

The monitoring element and the pixel has V_2 ($V_{cathode}$) in common. That means V_{ds} of the driver transistor of the pixel is set as well.

In this manner, this embodiment mode is characterized by determining V_{ds} . Further, this embodiment mode in which V_{ds} is directly controlled provides a simpler method for setting a voltage as compared to Embodiment Mode 1 in which I_{ds} is determined.

As described above, according to the invention, it is possible to obtain a setting voltage without a deterioration margin (voltage a) from the time the light emitting element starts emitting light. Therefore, a margin of the setting voltage in accordance with a deterioration of the light emitting element is not required, thus heat generation and power consumption can be reduced. Particularly, by the reduction in heat generation of the driver transistor, the deterioration of the light emitting element can be prevented.

Embodiment Mode 3

Hereinafter explained is a different pixel structure from those of Embodiment Mode 1 and Embodiment Mode 2.

FIG. 10 shows a circuit diagram as described in Embodiment Mode 2, wherein a switching regulator 3000 is applied in stead of an operational amplifier as a power source voltage controller. For a constitution where an operational amplifier is applied, a power source circuit for the operational amplifier is required. This embodiment mode makes it possible to unite an operational amplifier and the power source circuit by using a switching regulator.

A pixel structure which has a switching regulator will be hereinafter described. In FIG. 10, the switching regulator 3000 is comprised of an error amplifier 3001, a PWN comparator 3002, a reference power sources 3003 and 3010, an oscillation circuit 3004, a switching transistor 3008, an inductor 3009, a diode 3006, a smoothing capacitor 3005 and a battery 3007. As well as Embodiment Mode 2, a monitoring element has a driver transistor 3011 and a light emitting element 3012 which is connected to a first electrode of the driver transistor 3011. A pixel has a driver transistor 3013 and a light emitting element 3014 which is connected to a first electrode of the driver transistor 3013. Gate electrodes of the driver transistors 3011 and 3013 are connected to a power source 3015 and second electrodes of the transistors 3011 and 3013 are connected to a power source 3016.

Next, an operation of the switching regulator will be explained. At the start of operating, a potential of the smooth-

ing capacitor **3005** which is an output of the switching regulator is 0. The potential of the smoothing capacitor is inputted to an inverted input terminal of the error amplifier **3001**, and a potential of the light emitting element is inputted to a non-inverted input terminal. A current of the transistor **3011** flows in the light emitting element **3012** and a voltage is generated in the light emitting element. When the voltage is higher than that of the reference power source **3010**, the error amplifier **3001** operates so as to lower the output. Then, the PWN comparator **3002** operates so as to lower the voltage of the inductor **3009** by changing the duty of the oscillation. Therefore, a potential of the smoothing capacitor **3005** is lowered and an anode potential of the light emitting element **3012** is also lowered to become approximately the same potential as the power source **3010**. Meanwhile, when an anode potential of the light emitting element **3012** is lower than that of the reference power source **3010**, the opposite operation is taken, and the anode potential rises to the same potential as the reference power source **3010**.

In this manner, the same effect as that of an operational amplifier can be obtained by using the switching regulator **3000**. Also, a power source can be reduced.

Embodiment Mode 4

Hereinafter explained with reference to FIGS. **5** and **6** is the pixel portion having a monitoring element. Note that a thin film transistor (hereinafter referred to as TFT) formed over an insulating surface is employed as a transistor of an active element in this embodiment mode.

Shown in FIG. **5** is an equivalent circuit diagram of a pixel portion **500** having a first dummy pixel **501**, a monitoring element **502**, a second dummy pixel **503** and a pixel **504** in this order. The first and second dummy pixels are provided so that the whole pixel portion is under the equal condition including the pixels at the edge as well as the pixels around them.

The dummy pixel, the monitoring element and the pixel have similar structures, having a first TFT (selector TFT) **511**, a second TFT (erasure TFT) **512**, a third TFT (driver TFT) **513**, a capacitor element **514**, and a light emitting element **515** at the crossed part of a signal line **521** and a first scanning line **522**. Note that the selector TFT and the erasure TFT are formed by using n-channel type TFTs, and the driver TFT is formed by using a p-channel type TFT in this embodiment mode. Also, a second scanning line **523** which is connected to a gate electrode of the erasure TFT, and a current supply line **524** which is connected to a first electrode of the erasure TFT and a first electrode of the driver TFT are provided.

The dummy pixel, the monitoring element and the pixel, however, vary in connections of each structure. First and second dummy pixels are not connected to the first electrode of the selector TFT **511** and the signal line **521**. Secondly, the first electrode of the driver TFT **513** is not connected to the first electrode of the light emitting element **515**. These dummy pixels are provided in order to operate the whole pixels under the same condition including the pixels at the edge as well as the pixels around them. Therefore, dummy pixels neither need to emit light, write data from the signal line to pixels, nor make the light emitting element emit light. In the invention, however, the dummy pixel may emit light. The signal line **521** of the dummy pixel and the current supply line **524** are connected to each other to have the same potentials.

In the monitoring element, the first electrode of the selector TFT **511** is not connected to the signal line **521**. The signal line **521**, however, is connected to the first electrode of the

light emitting element **515**. This is intended to make the monitoring element emit light constantly so that the deterioration thereof proceeds fast. Therefore, voltage applied from the signal line as information for brightness does not have to go through the selector TFT **511** to be inputted to the light emitting element. The signal line **521** and the current supply line **524** of the monitor element are connected to an operational amplifier respectively.

In the pixel, the first electrode of the selector TFT **511** is connected to the signal line **521**, and a first electrode of the driver TFT **513** is connected to the first electrode of the light emitting element **515**. It is intended that in the pixel, the light emitting element **515** emits light through the driver TFT **513** based on the signal voltage from the signal line. Furthermore, the signal line **521** and the current supply line **524** of the pixel are connected to the driver circuit and an FPC respectively.

In FIG. **6**, a top plan view of a part of the pixel portion shown in FIG. **5** is shown. The first dummy pixel **501**, the monitoring element **502**, the second dummy pixel **503**, and the pixel **504** of the first line are shown. These dummy pixels, monitoring elements and pixels have the selector TFT **511**, the erasure TFT **512**, the driver TFT **513**, and the light emitting element **515** (only the first electrode thereof is shown) at the crossed parts of the signal line **521**, the current supply line **524**, the first scanning line **522**, and the second scanning line **523**. A capacitor element **514** (configured with a gate metal and a semiconductor film of the TFT **513**) is provided as needed. Note that, another capacitor element is added when the gate capacitor of the driver TFT is too small for the leakage current of the TFT.

As described above with reference to FIG. **5**, these dummy pixels, the monitoring element, and the pixel have the identical structures, however, the presence of contacts differs. That is, what differs in the dummy pixels, the monitoring element, and the pixel is whether the connection between the selector TFT **511** and the signal line **521** and the connection between the driver TFT **513** and the light emitting element **515** exist or not.

In the first and second dummy pixels, there are no contacts in the contact portion of the selector TFT **511** and the signal line **521**, and in the contact portion of the driver TFT **513** and the first electrode of the light emitting element **515**. The monitoring element, however, is provided with a contact **601** with the signal line **521** in the contact portion of the driver TFT **513** and the light emitting element **515**, although there is no contact in the contact portion of the selector TFT **511** and the signal line **521**. In the pixel, there is a contact **602** in the contact portion of the selector TFT **511** and the signal line **521**, and a contact **603** in the contact portion of the driver TFT **513** and the light emitting element **515**.

Furthermore, a leading wiring is provided so that the signal line and the current supply line of the monitoring element are connected to the operational amplifier. Moreover, the signal line and the current supply line of the pixel are connected to an FPC terminal **506** or a driver circuit respectively. The signal line and the current supply line of the dummy pixel are connected to each other and have the same potentials.

The monitoring element is not necessarily required in a whole line, but has only to be provided one. It depends on the performance of the operational amplifier to which the monitoring element is connected. The monitoring elements may be provided in plural, and also can be disposed symmetrically to the pixel portion. The monitoring element may be disposed in any forms.

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A line of monitoring elements are connected to each other in parallel through the current supply line, and a plurality of monitoring elements can be seen as one big monitoring element.

In this manner, the monitoring element of the invention can be formed by changing the layout design of the element, without changing the process of the pixel. Also, the setting voltage of the pixel can be at the best voltage in the saturation region at all times by utilizing the monitoring element formed thereby. Therefore, heat generation and power consumption can be reduced, resulting in the longer life of the light emitting element.

Embodiment Mode 5

The pixel portion shown in the above embodiment mode is provided light emitting elements and sealed not to be exposed to the air, thus completing a panel. ICs including an operational amplifier, a controller, and a power source circuit and the like are mounted on the panel, thus completing a display module. The specific structure of the display module is explained here.

A pattern diagram provided with a line of monitoring elements **751** near the signal line driver circuit **705** is shown in FIG. **11A**. The monitoring element shown in FIG. **11A** comprises a signal line driving circuit **4001**, a scanning line driving circuit **4002**, a plurality of dummy pixels **4003**, a plurality of pixels **4004** and a monitoring element **4005**. The invention has monochrome light emitting elements when the monitoring elements are provided in one line as shown in FIG. **11A**. Therefore, it is desirable to apply it to a display device which expresses RGB with a color converting layer.

Furthermore, the monitoring elements may be provided in a plurality of lines or at a plurality of portions as shown in FIG. **11B**. The monitoring element shown in FIG. **11A** comprises a signal line driving circuit **4001**, a scanning line driving circuit **4002**, a plurality of dummy pixels **4003**, a plurality of pixels **4004**, a 1st monitoring element (R) **4006**, a 1st monitoring element (G) **4007** and a 1st monitoring element (B) **4008**. When providing the monitoring elements in a large panel particularly, it is desirable that the monitoring elements be provided in a plurality of lines although it depends on the performance of the operational amplifier. At the same time, first to third monitoring elements had better be provided in consideration of the difference of deteriorations between the materials for each color (RGB) as shown in FIG. **11B**. The place to dispose each monitoring element is not exclusively applied to FIG. **11B**. It may be disposed at any peripheral region of the pixel, including outside thereof.

An outline view of the display module of the structure of FIG. **11A** is shown in FIG. **7A**. The display module is mounting an operational amplifier **750**, a controller **701** and a power source circuit **702**. A pixel portion **703** in which a light emitting element is formed in each pixel, a monitoring element **751** and a dummy pixel **752** are mounted, a scanning line driver circuit **704** for selecting pixels in the pixel portion **703**, and a signal line driver circuit **705** for supplying a video signal to the selected pixels are formed in the panel **700**. The monitoring element **751** is disposed near the signal line driver circuit **705** as one side of the pixel portion **703** and connected to the operational amplifier **750**. In addition, the dummy pixel **752** is provided around (periphery of) the pixel portion **703** in order to put the pixels at the edge (the most outside pixels. In case of $m \times n$ pixels, and a pixel in the first row and the first line, a pixel in the m -th row and the n -th line) under the same condition as the peripheral pixels.

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Similarly, the dummy pixel **752** may be disposed at the necessary periphery only although it is disposed around the pixel portion **703** in the figure. Also, the place and number of the signal line driver circuit and the scanning line driver circuit to dispose are not limited to FIG. **7A**.

Further, the operational amplifier **750**, the controller **701** and the power source circuit **702** are formed over a printed circuit board **706**. Each type of signal and a power source voltage outputted from the controller **701** or the power source circuit **702** are supplied through an FPC **707** to the pixel portion **703**, the scanning line driver circuit **704**, and the signal line driver circuit **705** of the panel **700**.

The power source voltage and each type of signal are supplied to the printed circuit board **706** through an interface (I/F) portion **708** on which a plurality of input terminals are disposed.

Note that although the printed circuit board **706** is mounted via an FPC **707** on the panel **700** in this embodiment mode, the structure is not necessarily limited to this. The controller **701** and the power source circuit **702** may also be mounted directly on the panel **700** by using a COG (Chip on Glass) method.

Further, noise may ride on the power source voltage and the signals, and the signal rise time may become slowed, due to capacitance that are formed between leading wirings, resistance of wirings themselves, and the like of the printed circuit board **706**. Various types of elements, such as capacitors and buffers, may be formed over the printed circuit board **706** so as to prevent noise from riding on the power source voltage or the signals, and slowness in the signal rise time.

A block diagram of the structure of the printed circuit board **706** is shown in FIG. **7B**. Each type of signal and the power source voltage supplied by the interface **708** are supplied to the controller **701** and the power source circuit **702**.

The controller **701** has an A/D converter **709**, a phase locked loop (PLL) **710**, a control signal generator portion **711**, and SRAMs (Static Random Access Memories) **712** and **713**. Note that, although SRAMs are used here, it is also possible to use SDRAMs or DRAMs (Dynamic Random Access Memories) as substitutes for the SRAMs, provided that the DRAMs are capable of writing and reading data at a high speed.

A video signal supplied through the interface **708** is subjected to a parallel-serial conversion in the A/D converter **709**, and inputted to the control signal generator portion **711** as a video signal corresponding to the colors R, G and B (R video signal **714**, G video signal **715** and B video signal **716**). Further, an Hsync signal **717**, a Vsync signal **718**, a clock signal CLK (CLK1 **719** and CLK2 **720**), and alternating voltage (AC Cont **721**) are generated in the A/D converter **709** based on each of the signals supplied through the interface **708**, and then inputted to the control signal generator portion **711**.

The phase locked loop **710** functions to align the phase of the operating frequency of the control signal generator portion **711** with the frequency of each of the signals supplied through the interface **708**. The operating frequency of the control signal generator portion **711** is not necessarily the same as the frequency of each of the signals supplied through the interface **708**. The operating frequency of the control signal generator portion **711** is regulated in the phase locked loop **710** so that the frequencies become synchronized.

The video signal inputted to the control signal generator portion **711** is temporarily written into the SRAMs **712** and **713**, and stored. A video signal corresponding to all pixels is read out one bit at a time from the video signals of all of the

bits that are stored in the SRAM 712, and then supplied to the signal line driver circuit 705 of the panel 700.

The control signal generator portion 711 supplies information, which relates to light emission periods by the light emitting elements for each bit, to the scanning line driver circuit 704 of the panel 700.

The power source circuit 702 supplies a predetermined power source voltage to the signal line driver circuit 705, the scanning line driver circuit 704, and the pixel portion 703 of the panel 700.

The display module formed like this can set the best setting voltage in the saturation region all the time by utilizing the monitoring element. Therefore, heat generation and power consumption can be reduced, resulting in the longer life of the light emitting element.

Embodiment Mode 6

Given as examples of electronic apparatuses that employ display devices manufactured in accordance with the invention are video cameras, digital cameras, goggle type displays (head mounted displays), navigation systems, audio playback devices (car audios, audio components, etc.), notebook type personal computers, game machines, portable information terminals (mobile computers, mobile telephones, mobile type game machines, and electronic books, etc.), image reproduction devices equipped with a recording medium (specifically, devices equipped with a display device capable of reproducing the recording medium such as a Digital Versatile Disk (DVD), etc. and displaying the image thereof), and the like. Examples of these electronic apparatuses are shown in FIG. 9.

FIG. 9A is a display device, which is composed of a frame 2001, a support base 2002, a display portion 2003, a speaker portion 2004, a video input terminal 2005, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2003 to manufacture the display device. Note that in the case of manufacturing a large-sized display device, the monitoring elements are provided in a plurality of rows or more preferably at every RGBs. When the invention is applied to such a display device, particularly to a large-sized display device, the low power consumption is achieved, thus the problems of the heat generation and the deterioration of the light emitting elements can be solved. Note that the term display device includes all display devices for displaying information, such as those for personal computers, those for receiving TV broadcasting, and those for advertising.

FIG. 9B is a digital still camera, which is composed of a main body 2101, a display portion 2102, an image-receiving portion 2103, operation keys 2104, an external connection port 2105, a shutter 2106, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2102 to manufacture the digital still camera.

FIG. 9C is a notebook type personal computer, which is composed of a main body 2201, a frame 2202, a display portion 2203, a keyboard 2204, an external connection port 2205, a pointing mouse 2206, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2203 to manufacture the notebook type personal computer.

FIG. 9D is a mobile computer, which is composed of a main body 2301, a display portion 2302, a switch 2303, operation keys 2304, an infrared port 2305, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2302 to manufacture the mobile computer.

Mobile apparatuses such as a notebook type personal computer and a mobile computer which has a pixel portion having a monitoring element of the invention have advantages in that power consumption is reduced and the storage period of a battery is prolonged.

FIG. 9E is a portable image reproduction device provided with a recording medium (specifically, a DVD playback device), which is composed of a main body 2401, a frame 2402, a display portion A 2403, a display portion B 2404, a recording medium (such as a DVD) read-in portion 2405, operation keys 2406, a speaker portion 2407, and the like. The display portion A 2403 mainly displays image information, and the display portion B 2404 mainly displays character information, and the pixel portion having a monitoring element of the invention is used in the display portion A 2403 and in the display portion B 2404 to manufacture the portable image reproduction device. Note that image reproduction devices provided with a recording medium include game machines for domestic use and the like.

FIG. 9F is a goggle type display (head mounted display) which is composed of a main body 2501, a display portion 2502, an arm 2503. The pixel portion having a monitoring element of the invention is used in the display portion 2502 to manufacture the goggle type display.

FIG. 9G is a video camera, which is composed of a main body 2601, a display portion 2602, a frame 2603, an external connection port 2604, a remote control receiving portion 2605, an image receiving portion 2606, a battery 2607, an audio input portion 2608, operation keys 2609, an eyepiece portion 2610, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2602 to manufacture the video camera.

FIG. 9H is a mobile telephone, which is composed of a main body 2701, a frame 2702, a display portion 2703, an audio input portion 2704, an audio output portion 2705, operation keys 2706, an external connection port 2707, an antenna 2708, and the like. The pixel portion having a monitoring element of the invention is used for the display portion 2703 to manufacture the mobile telephone. Note that by displaying white characters on a black background, the display portion 2703 can suppress power consumption of the mobile telephone.

As described above, the application scope of the invention is so wide that it can be used in electronic apparatuses of various fields, particularly to a flat panel display.

EMBODIMENT

Embodiment 1

Hereinafter explained is an experimental result with respect to a change of a cathode voltage (cathode potential) corresponding to a secular change and a current which is supplied to a light emitting element. Incidentally, this embodiment mode applies an experimental circuit to which a circuit as shown in FIG. 10 is applied.

FIG. 12 shows a circuit diagram of this embodiment to which a circuit diagram of FIG. 10 is applied. For a power source circuit, a μ PC1100 (produced by NEC Corporation) is used. A resistance R1 is set so that a voltage of a VMO terminal can be approximately 1.05 to 1.45V. A resistance R2 is set so that a driver TFT of a monitoring element can operate in a saturation region. A resistance R3 is set so that a voltage of a DTC terminal can be approximately 1.87V. A power source voltage Vcc is set at a voltage of 7V. A CATHODE terminal is connected to a cathode of a light emitting element of a pixel and a cathode of a light emitting element of the

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monitoring element. A MONITOR terminal is connected to an anode of the light emitting element of the monitoring element. Meanwhile, second electrodes of driver TFTs of the pixel and the monitoring element and which are not connected to the light emitting elements are fixed at 5V.

Shown in FIGS. 13 and 14 are the results of experiment conducted by using the circuit as shown in FIG. 12. FIG. 13 shows a change of a cathode potential ($V_{cathode}$) with the passage of time (hour). It can be confirmed that an absolute value of the cathode potential ($V_{cathode}$) rises as time passes. Meanwhile, FIG. 14 shows a current value (I) which is supplied to a light emitting element with the passage of time (hour). It can be confirmed that a constant current value is supplied to the light emitting element. Note that the current value supplied to the light emitting element is equal to the current consumption.

The longer the light emitting element emits light, the faster the light emitting element deteriorates and the higher the absolute value of the required cathode voltage becomes. However, the current value supplied to the light emitting element does not change. Accordingly, the circuit of the invention can control the cathode voltage normally in order to keep the current value supplied to the light emitting element constant.

By using the pixel structure provided with the circuit of the invention, it is possible to operate a driver TFT in a saturation region without a deterioration margin of the light emitting element, or with a smaller margin than the conventional one. Therefore, heat generation and power consumption can be reduced.

The invention makes it possible to set a voltage in a saturation region without a deterioration margin of a light emitting element, or with a smaller margin than the conventional one from the time the light emitting element starts emitting light. Therefore, the margin of the setting voltage in accordance with the deterioration of the light emitting element is not required, leading to the reduced heat generation and power consumption. Further, the deterioration of the light emitting element can be prevented particularly because heat generation of the driver transistor is reduced.

What is claimed is:

1. A display device comprising:

a first transistor;

a second transistor;

a third transistor electrically connected to the second transistor;

a first light emitting element including a first electrode; and a second light emitting element including a second electrode,

wherein the first electrode overlaps with at least a part of the first transistor,

wherein the second electrode overlaps with at least a part of the second transistor,

wherein the first transistor is electrically connected to the first electrode,

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wherein the second transistor is not electrically connected to the second electrode,

wherein a signal line overlaps with a part of the third transistor, and

wherein the third transistor is not electrically connected to the signal line.

2. A display device according to claim 1, wherein the first transistor and the second transistor are thin film transistors.

3. A display device comprising:

a first transistor;

a second transistor;

a third transistor electrically connected to the second transistor;

an insulating film over the first transistor and the second transistor;

a first light emitting element including a first electrode on the insulating film; and

a second light emitting element including a second electrode on the insulating film,

wherein the first electrode overlaps with at least a part of the first transistor,

wherein the second electrode overlaps with at least a part of the second transistor,

wherein a contact hole is provided in the insulating film, and the first transistor is electrically connected to the first electrode through the contact hole,

wherein the second transistor is not electrically connected to the second electrode,

wherein a signal line overlaps with a part of the third transistor, and

wherein the third transistor is not electrically connected to the signal line.

4. A display device according to claim 3, wherein the first transistor and the second transistor are thin film transistors.

5. A light emitting device comprising:

a first transistor and a first light emitting element having a first electrode connected to a first electrode of the first transistor;

a monitoring element having a second transistor and a second light emitting element having a first electrode connected to a first electrode of the second transistor; and

a power source voltage controller,

wherein an input terminal of the power source voltage controller is connected to second electrodes of the first and second transistors respectively; and

an output terminal of the power source voltage controller is connected to second electrodes of the first and second light emitting elements.

6. A light emitting device according to claim 5,

wherein the power source voltage controller is an operational amplifier.

7. A light emitting device according to claim 5,

wherein the power source voltage controller is a switching regulator.

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